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ANALOG DEVICES

SHARC® DSP Microcomputer

ADSP-21160M

SUMMARY

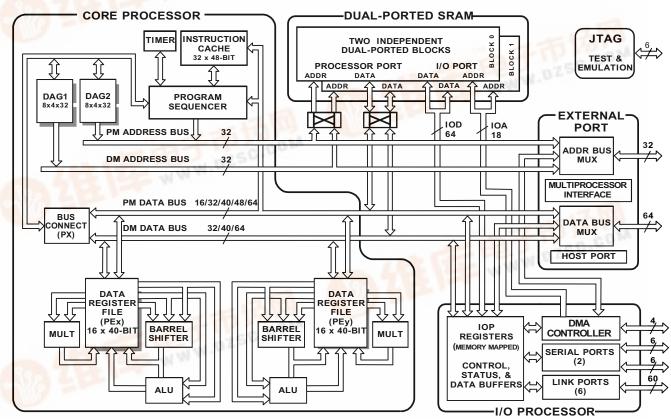
- High-Performance 32-Bit DSP—Applications in Audio, Medical, Military, Graphics, Imaging, and Communication
- Super Harvard Architecture Four Independent Buses for Dual Data Fetch, Instruction Fetch, and Nonintrusive, Zero-Overhead I/O
- Backwards-Compatible Assembly Source Level Compatible with Code for ADSP-2106x DSPs
- Single-Instruction-Multiple-Data (SIMD) Computational Architecture – Two 32-Bit IEEE Floating-Point Computation Units, Each with a Multiplier, ALU, Shifter, and Register File
- Integrated Peripherals—Integrated I/O Processor, 4M Bit On-Chip Dual-Ported SRAM, Glueless Multiprocessing Features, and Ports (Serial, Link, External Bus, and JTAG)

KEY FEATURES

80 MHz (12.5 ns) Core Instruction Rate Single-Cycle Instruction Execution, Including SIMD Operations in Both Computational Units

- 480 MFLOPS Peak and 320 MFLOPS Sustained Performance (Based on FIR)
- Dual Data Address Generators (DAGs) with Modulo and Bit-Reverse Addressing
- Zero-Overhead Looping and Single-Cycle Loop Setup, Providing Efficient Program Sequencing
- IEEE 1149.1 JTAG Standard Test Access Port and On-Chip Emulation
- 400-Ball 27 × 27 mm Metric PBGA Package

FUNCTIONAL BLOCK DIAGRAM



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FEATURES (CONTINUED)

Single Instruction Multiple Data (SIMD) Architecture Provides:

Two Computational Processing Elements

Concurrent Execution – Each Processing Element Executes the Same Instruction, but Operates on Different Data

Code Compatibility—at Assembly Level, Uses the Same Instruction Set as the ADSP-2106x SHARC DSPs

Parallelism in Buses and Computational Units Allows: Single-cycle Execution (with or without SIMD) of: A Multiply Operation, An ALU Operation, A Dual Memory Read or Write, and An Instruction Fetch

- Transfers Between Memory and Core at up to Four 32-Bit Floating- or Fixed-Point Words per Cycle Accelerated FFT Butterfly Computation Through a
- Multiply with Add and Subtract 4M Bit On-Chip Dual-Ported SRAM for Independent Access by Core Processor, Host, and DMA

DMA Controller supports:

- 14 Zero-Overhead DMA Channels for Transfers Between ADSP-21160M Internal Memory and External Memory, External Peripherals, Host Processor, Serial Ports, or Link Ports
- 64-Bit Background DMA Transfers at Core Clock Speed, in Parallel with Full-Speed Processor Execution 560M Bytes/s Transfer Rate Over IOP Bus

Host Processor Interface to 16- and 32-Bit Microprocessors

4G Word Address Range for Off-Chip Memory

Memory Interface Supports Programmable Wait State Generation and Page-Mode for Off-Chip Memory

- **Multiprocessing Support Provides:**
 - Glueless Connection for Scalable DSP Multiprocessing Architecture
 - Distributed On-Chip Bus Arbitration for Parallel Bus Connect of up to Six ADSP-21160Ms plus Host Six Link Ports for Point-To-Point Connectivity and Array
 - Multiprocessing
- Serial Ports Provide:

Two 40M Bit/s Synchronous Serial Ports with Companding Hardware

- **Independent Transmit and Receive Functions**
- **TDM Support for T1 and E1 Interfaces**
- 64-Bit Wide Synchronous External Port Provides:
- Glueless Connection to Asynchronous and SBSRAM External Memories
- Up to 40 MHz Operation

GENERAL DESCRIPTION

The ADSP-21160M SHARC DSP is the first processor in a new family featuring Analog Devices' Super Harvard Architecture. Easing portability, the ADSP-21160M is application source code compatible with first generation ADSP-2106x SHARC DSPs in SISD (Single Instruction, Single Data) mode. To take advantage of the processor's SIMD (Single Instruction, Multiple Data) capability, some code changes are needed. Like other SHARCs, the ADSP-21160M is a 32-bit processor that is optimized for high performance DSP applications. The ADSP-21160M includes an 80 MHz core, a dual-ported on-chip SRAM, an integrated I/O processor with multiprocessing support, and multiple internal buses to eliminate I/O bottlenecks.

The ADSP-21160M introduces Single-Instruction, Multiple-Data (SIMD) processing. Using two computational units (ADSP-2106x SHARC DSPs have one), the ADSP-21160M can double performance versus the ADSP-2106x on a range of DSP algorithms.

Fabricated in a state of the art, high speed, low power CMOS process, the ADSP-21160M has a 12.5 ns instruction cycle time. With its SIMD computational hardware running at 80 MHz, the ADSP-21160M can perform 480 million math operations per second.

Table 1 shows performance benchmarks for theADSP-21160M.

Table 1. ADSP-21160M Benchmarks

Benchmark Algorithm	Speed
1024 Point Complex FFT (Radix 4, with	115 μs
reversal)	
FIR Filter (per tap)	6.25 ns
IIR Filter (per biquad)	25 ns
Matrix Multiply (pipelined)	56.25 ns
[3×3] × [3×1]	
Matrix Multiply (pipelined)	100 ns
$[4 \times 4] \times [4 \times 1]$	
Divide (y/x)	37.5 ns
Inverse Square Root	56.25 ns
DMA Transfer Rate	560M Bytes/s

These benchmarks provide single-channel extrapolations of measured dual-channel processing performance. For more information on benchmarking and optimizing DSP code for single- and dual-channel processing, see Analog Devices's website.

The ADSP-21160M continues SHARC's industry-leading standards of integration for DSPs, combining a high-performance 32-bit DSP core with integrated, on-chip system features. These features include a 4M bit dual ported SRAM memory, host processor interface, I/O processor that supports 14 DMA channels, two serial ports, six link ports, external parallel bus, and glueless multiprocessing.

The functional block diagram on page 1 shows a block diagram of the ADSP-21160M, illustrating the following architectural features:

- Two processing elements, each made up of an ALU, Multiplier, Shifter, and Data Register File
- Data Address Generators (DAG1, DAG2)
- Program sequencer with instruction cache
- PM and DM buses capable of supporting four 32-bit data transfers between memory and the core every core processor cycle
- Interval timer
- On-Chip SRAM (4 Mbit)
- External port that supports:
 - · Interfacing to off-chip memory peripherals
 - Glueless multiprocessing support for six ADSP-21160M SHARCs
 - Host port
- DMA controller
- Serial ports and link ports
- JTAG test access port

Figure 1 shows a typical single-processor system. A multiprocessing system appears in Figure 4.

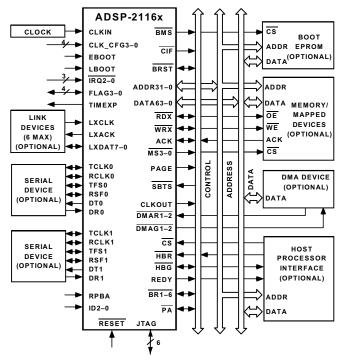


Figure 1. Single-Processor System

ADSP-21160M Family Core Architecture

The ADSP-21160M includes the following architectural features of the ADSP-2116x family core. The ADSP-21160M is code compatible at the assembly level with the ADSP-21060, ADSP-21061, and ADSP-21062.

SIMD Computational Engine

The ADSP-21160M contains two computational processing elements that operate as a Single Instruction Multiple Data (SIMD) engine. The processing elements are referred to as PEX and PEY, and each contains an ALU, multiplier, shifter, and register file. PEX is always active, and PEY may be enabled by setting the PEYEN mode bit in the MODE1 register. When this mode is enabled, the same instruction is executed in both processing elements, but each processing element operates on different data. This architecture is efficient at executing math-intensive DSP algorithms.

Entering SIMD mode also has an effect on the way data is transferred between memory and the processing elements. When in SIMD mode, twice the data bandwidth is required to sustain computational operation in the processing elements. Because of this requirement, entering SIMD mode also doubles the bandwidth between memory and the processing elements. When using the DAGs to transfer data in SIMD mode, two data values are transferred with each access of memory or the register file.

Independent, Parallel Computation Units

Within each processing element is a set of computational units. The computational units consist of an arithmetic/logic unit (ALU), multiplier, and shifter. These units perform single-cycle instructions. The three units within each processing element are arranged in parallel, maximizing computational throughput. Single multifunction instructions execute parallel ALU and multiplier operations. In SIMD mode, the parallel ALU and multiplier operations occur in both processing elements. These computation units support IEEE 32-bit single-precision floating-point, 40-bit extended precision floating-point, and 32-bit fixed-point data formats.

Data Register File

A general-purpose data register file is contained in each processing element. The register files transfer data between the computation units and the data buses, and store intermediate results. These 10-port, 32-register (16 primary, 16 secondary) register files, combined with the ADSP-2116x enhanced Harvard architecture, allow unconstrained data flow between computation units and internal memory. The registers in PEX are referred to as R0–R15 and in PEY as S0–S15.

Single-Cycle Fetch of Instruction and Four Operands

The ADSP-21160M features an enhanced Harvard architecture in which the data memory (DM) bus transfers data, and the program memory (PM) bus transfers both instructions and data (see the functional block diagram on page 1).

With the ADSP-21160M's separate program and data memory buses and on-chip instruction cache, the processor can simultaneously fetch four operands and an instruction (from the cache), all in a single cycle.

Instruction Cache

The ADSP-21160M includes an on-chip instruction cache that enables three-bus operation for fetching an instruction and four data values. The cache is selective—only the instructions whose fetches conflict with PM bus data accesses are cached. This cache allows full-speed execution of core, providing looped operations such as digital filter multiply- accumulates and FFT butterfly processing.

Data Address Generators with Hardware Circular Buffers

The ADSP-21160M's two data address generators (DAGs) are used for indirect addressing and provide for implementing circular data buffers in hardware. Circular buffers allow efficient programming of delay lines and other data structures required in digital signal processing, and are commonly used in digital filters and Fourier transforms. The two DAGs of the ADSP-21160M contain sufficient registers to allow the creation of up to 32 circular buffers (16 primary register sets, 16 secondary). The DAGs automatically handle address pointer wraparound, reducing overhead, increasing performance, and simplifying implementation. Circular buffers can start and end at any memory location.

Flexible Instruction Set

The 48-bit instruction word accommodates a variety of parallel operations, for concise programming. For example, the ADSP-21160M can conditionally execute a multiply, an add, and subtract, in both processing elements, while branching, all in a single instruction.

ADSP-21160M Memory and I/O Interface Features

Augmenting the ADSP-2116x family core, the ADSP-21160M adds the following architectural features:

Dual-Ported On-Chip Memory

The ADSP-21160M contains four megabits of on-chip SRAM, organized as two blocks of 2 Mbits each, which can be configured for different combinations of code and data storage. Each memory block is dual-ported for single-cycle, independent accesses by the core processor and I/O processor. The dual-ported memory in combination with three separate on-chip buses allows two data transfers from the core and one from I/O processor, in a single cycle. On the ADSP-21160M, the memory can be configured as a maximum of 128K words of 32-bit data, 256K words of 16-bit data, 85K words of 48-bit instructions (or 40-bit data), or combinations of different word sizes up to four megabits. All of the memory can be accessed as 16-bit, 32-bit, 48-bit, or 64-bit words. A 16-bit floating-point storage format is supported that effectively doubles the amount of data that may be stored on-chip. Conversion

between the 32-bit floating-point and 16-bit floating-point formats is done in a single instruction. While each memory block can store combinations of code and data, accesses are most efficient when one block stores data, using the DM bus for transfers, and the other block stores instructions and data, using the PM bus for transfers. Using the DM bus and PM bus in this way, with one dedicated to each memory block, assures single-cycle execution with two data transfers. In this case, the instruction must be available in the cache.

Off-Chip Memory and Peripherals Interface

The ADSP-21160M's external port provides the processor's interface to off-chip memory and peripherals. The 4G word off-chip address space is included in the ADSP-21160M's unified address space. The separate on-chip buses-for PM addresses, PM data, DM addresses, DM data, I/O addresses, and I/O data—are multiplexed at the external port to create an external system bus with a single 32-bit address bus and a single 64-bit data bus. The lower 32 bits of the external data bus connect to even addresses and the upper 32 bits of the 64 connect to odd addresses. Every access to external memory is based on an address that fetches a 32-bit word, and with the 64-bit bus, two address locations can be accessed at once. When fetching an instruction from external memory, two 32-bit data locations are being accessed (16 bits are unused). Figure 3 shows the alignment of various accesses to external memory.

The external port supports asynchronous, synchronous, and synchronous burst accesses. ZBT synchronous burst SRAM can be interfaced gluelessly. Addressing of external memory devices is facilitated by on-chip decoding of high-order address lines to generate memory bank select signals. Separate control lines are also generated for simplified addressing of page-mode DRAM. The ADSP-21160M provides programmable memory wait states and external memory acknowledge controls to allow interfacing to DRAM and peripherals with variable access, hold, and disable time requirements.

DMA Controller

The ADSP-21160M's on-chip DMA controller allows zero-overhead data transfers without processor intervention. The DMA controller operates independently and invisibly to the processor core, allowing DMA operations to occur while the core is simultaneously executing its program instructions. DMA transfers can occur between the ADSP-21160M's internal memory and external memory, external peripherals, or a host processor. DMA transfers can also occur between the ADSP-21160M's internal memory and its serial ports or link ports. External bus packing to 16-, 32-, 48-, or 64-bit words is performed during DMA transfers. Fourteen channels of DMA are available on the ADSP-21160M—six via the link ports, four via the serial ports, and four via the processor's external port (for either

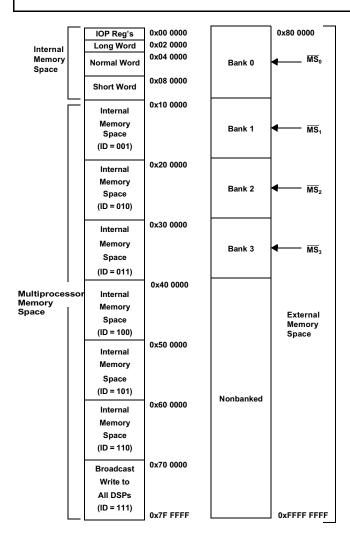


Figure 2. ADSP-21160M Memory Map

host processor, other ADSP-21160Ms, memory or I/O transfers). Programs can be downloaded to the ADSP-21160M using DMA transfers. Asynchronous off-chip peripherals can control two DMA channels using DMA Request/Grant lines (DMAR1–2, DMAG1–2). Other DMA features include interrupt generation upon completion of DMA transfers, two-dimensional DMA, and DMA chaining for automatic linked DMA transfers.

Multiprocessing

The ADSP-21160M offers powerful features tailored to multiprocessing DSP systems as shown in Figure 4. The external port and link ports provide integrated glueless multiprocessing support.

The external port supports a unified address space (see Figure 2) that allows direct interprocessor accesses of each ADSP-21160M's internal memory. Distributed bus arbitration logic is included on-chip for simple, glueless connection of systems containing up to six ADSP-21160Ms and a host processor. Master processor changeover incurs only one cycle of overhead. Bus arbitration is selectable as either fixed

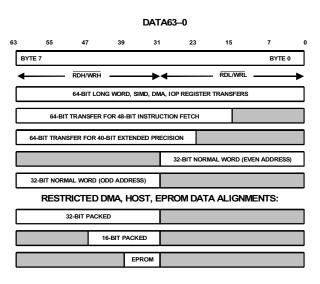


Figure 3. ADSP-21160M External Data Alignment Options

or rotating priority. Bus lock allows indivisible read-modify-write sequences for semaphores. A vector interrupt is provided for interprocessor commands. Maximum throughput for interprocessor data transfer is 320M bytes/s over the external port. Broadcast writes allow simultaneous transmission of data to all ADSP-21160Ms and can be used to implement reflective semaphores.

Six link ports provide for a second method of multiprocessing communications. Each link port can support communications to another ADSP-21160M. Using the links, a large multiprocessor system can be constructed in a 2D or 3D fashion. Systems can use the link ports and cluster multiprocessing concurrently or independently.

Link Ports

The ADSP-21160M features six 8-bit link ports that provide additional I/O capabilities. With the capability of running at 80 MHz rates, each link port can support 80M bytes/s. Link port I/O is especially useful for point-to-point interprocessor communication in multiprocessing systems. The link ports can operate independently and simultaneously. Link port data is packed into 48- or 32-bit words, and can be directly read by the core processor or DMA-transferred to on-chip memory. Each link port has its own double-buffered input and output registers. Clock/acknowledge handshaking controls link port transfers. Transfers are programmable as either transmit or receive. For data throughput information, see link port timing details in Table 18 on page 34.

Serial Ports

The ADSP-21160M features two synchronous serial ports that provide an inexpensive interface to a wide variety of digital and mixed-signal peripheral devices. The serial ports can operate up to half the clock rate of the core, providing each with a maximum data rate of 40M bit/s. Independent

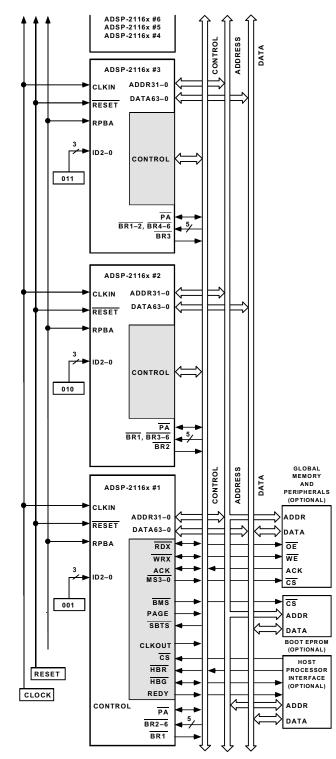


Figure 4. Shared Memory Multiprocessing System

transmit and receive functions provide greater flexibility for serial communications. Serial port data can be automatically transferred to and from on-chip memory via a dedicated DMA. Each of the serial ports offers a TDM multichannel mode. The serial ports can operate with little-endian or big-endian transmission formats, with word lengths selectable from 3 bits to 32 bits. They offer selectable synchronization and transmit modes as well as optional μ -law or A-law companding. Serial port clocks and frame syncs can be internally or externally generated.

Host Processor Interface

The ADSP-21160M host interface allows easy connection to standard microprocessor buses, both 16-bit and 32-bit, with little additional hardware required. The host interface is accessed through the ADSP-21160M's external port and is memory-mapped into the unified address space. Four channels of DMA are available for the host interface; code and data transfers are accomplished with low software overhead. The host processor communicates with the ADSP-21160M's external bus with host bus request (HBR), host but grant (HBG), ready (REDY), acknowledge (ACK), and chip select (CS) signals. The host can directly read and write the internal memory of the ADSP-21160M, and can access the DMA channel setup and mailbox registers. Vector interrupt support provides efficient execution of host commands.

Program Booting

The internal memory of the ADSP-21160M can be booted at system power-up from an 8-bit EPROM, a host processor, or through one of the link ports. Selection of the boot source is controlled by the BMS (Boot Memory Select), EBOOT (EPROM Boot), and LBOOT (Link/Host Boot) pins. 32-bit and 16-bit host processors can be used for booting.

Phased Locked Loop

The ADSP-21160M uses an on-chip PLL to generate the internal clock for the core. Ratios of 2:1, 3:1, and 4:1 between the core and CLKIN are supported. The CLK_CFG pins are used to select the ratio. The CLKIN rate is the rate at which the synchronous external port operates.

Power Supplies

The ADSP-21160M has separate power supply connections for the internal (V_{DDINT}), external (V_{DDEXT}), and analog (AV_{DD} /AGND) power supplies. The internal and analog supplies must meet the 2.5 V requirement. The external supply must meet the 3.3 V requirement. All external supply pins must be connected to the same supply.

Note that the analog supply (AV_{DD}) powers the ADSP-21160M's clock generator PLL. To produce a stable clock, the system must provide an external circuit to filter the power input to the AV_{DD} pin. Place the filter as close as possible to the pin. For an example circuit, see Figure 5. To prevent noise coupling, use a wide trace for the analog ground (AGND) signal and install a decoupling capacitor as close as possible to the pin.

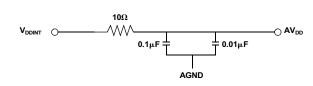


Figure 5. Analog Power (AV_{DD}) Filter Circuit

Development Tools

The ADSP-21160M is supported with a complete set of software and hardware development tools, including Analog Devices' emulators and VisualDSP++¹ development environment. The same emulator hardware that supports other ADSP-2116x DSPs, also fully emulates the ADSP-21160M.

The VisualDSP++ project management environment lets programmers develop and debug an application. This environment includes an easy-to-use assembler that is based on an algebraic syntax; an archiver (librarian/library builder), a linker, a loader, a cycle-accurate instruction-level simulator, a C/C++ compiler, and a C/C++ run-time library that includes DSP and mathematical functions. Two key points for these tools are:

- Compiled ADSP-2116x C/C++ code efficiency—the compiler has been developed for efficient translation of C/C++ code to ADSP-2116x assembly. The DSP has architectural features that improve the efficiency of compiled C/C++ code.
- ADSP-2106x family code compatibility—The assembler has legacy features to ease the conversion of existing ADSP-2106x applications to the ADSP-2116x.

Debugging both C/C++ and assembly programs with the VisualDSP++ debugger, programmers can:

- View mixed C/C++ and assembly code (interleaved source and object information)
- Insert break points
- Set conditional breakpoints on registers, memory, and stacks
- Trace instruction execution
- Perform linear or statistical profiling of program execution
- Fill, dump, and graphically plot the contents of memory
- Source level debugging
- · Create custom debugger windows

The VisualDSP++ IDE lets programmers define and manage DSP software development. Its dialog boxes and property pages let programmers configure and manage all of the ADSP-2116x development tools, including the syntax highlighting in the VisualDSP++ editor. This capability permits:

- Control how the development tools process inputs and generate outputs.
- Maintain a one-to-one correspondence with the tool's command line switches.

Analog Devices' DSP emulators use the IEEE 1149.1 JTAG test access port of the ADSP-21160M processor to monitor and control the target board processor during emulation. The emulator provides full-speed emulation, allowing inspection and modification of memory, registers, and processor stacks. Nonintrusive in-circuit emulation is assured by the use of the processor's JTAG interface—the emulator does not affect target system loading or timing.

In addition to the software and hardware development tools available from Analog Devices, third parties provide a wide range of tools supporting the ADSP-2116x processor family. Hardware tools include ADSP-2116x PC plug-in cards. Third Party software tools include DSP libraries, real-time operating systems, and block diagram design tools.

Designing an Emulator-Compatible DSP Board (Target)

The White Mountain DSP (Product Line of Analog Devices, Inc.) family of emulators are tools that every DSP developer needs to test and debug hardware and software systems. Analog Devices has supplied an IEEE 1149.1 JTAG Test Access Port (TAP) on each JTAG DSP. The emulator uses the TAP to access the internal features of the DSP, allowing the developer to load code, set breakpoints, observe variables, observe memory, and examine registers. The DSP must be halted to send data and commands, but once an operation has been completed by the emulator, the DSP system is set running at full speed with no impact on system timing.

To use these emulators, the target's design must include the interface between an Analog Devices' JTAG DSP and the emulation header on a custom DSP target board.

Target Board Header

The emulator interface to an Analog Devices' JTAG DSP is a 14-pin header, as shown in Figure 6. The customer must supply this header on the target board in order to communicate with the emulator. The interface consists of a standard dual row 0.025" square post header, set on $0.1" \times 0.1"$ spacing, with a minimum post length of 0.235". Pin 3 is the key position used to prevent the pod from being inserted backwards. This pin must be clipped on the target board.

¹VisualDSP++ is a registered trademark of Analog Devices, Inc.

Also, the clearance (length, width, and height) around the header must be considered. Leave a clearance of at least 0.15" and 0.10" around the length and width of the header, and reserve a height clearance to attach and detach the pod connector.

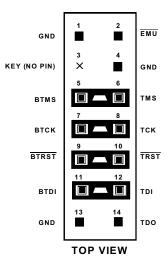


Figure 6. JTAG Target Board Connector for JTAG Equipped Analog Devices DSP (Jumpers in Place)

As can be seen in Figure 6, there are two sets of signals on the header. There are the standard JTAG signals TMS, TCK, TDI, TDO, TRST, and EMU used for emulation purposes (via an emulator). There are also secondary JTAG signals BTMS, BTCK, BTDI, and BTRST that are optionally used for board-level (boundary scan) testing.

When the emulator is not connected to this header, place jumpers across BTMS, BTCK, BTRST, and BTDI as shown in Figure 7. This holds the JTAG signals in the correct state to allow the DSP to run free. Remove all the jumpers when connecting the emulator to the JTAG header.

JTAG Emulator Pod Connector

Figure 8 details the dimensions of the JTAG pod connector at the 14-pin target end. Figure 9 displays the keep-out area for a target board header. The keep-out area allows the pod connector to properly seat onto the target board header. This board area should contain no components (chips, resistors, capacitors, etc.). The dimensions are referenced to the center of the 0.25" square post pin.

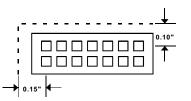


Figure 9. JTAG Pod Connector Keep-Out Area

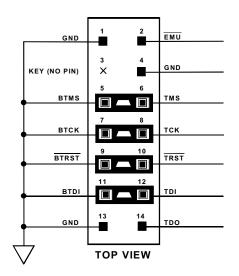


Figure 7. JTAG Target Board Connector with No Local Boundary Scan

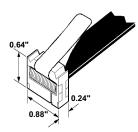


Figure 8. JTAG Pod Connector Dimensions

Design-for-Emulation Circuit Information

For details on target board design issues including: single processor connections, multiprocessor scan chains, signal buffering, signal termination, and emulator pod logic, see the *EE-68: Analog Devices JTAG Emulation Technical Reference* on the Analog Devices website—use site search on "EE-68" (www.analog.com). This document is updated regularly to keep pace with improvements to emulator support.

Additional Information

This data sheet provides a general overview of the ADSP-21160M architecture and functionality. For detailed information on the ADSP-2116x Family core architecture and instruction set, refer to the ADSP-2116x SHARC DSP Hardware Reference.

PIN FUNCTION DESCRIPTIONS

ADSP-21160M pin definitions are listed below. Inputs identified as synchronous (S) must meet timing requirements with respect to CLKIN (or with respect to TCK for TMS, TDI). Inputs identified as asynchronous (A) can be asserted asynchronously to CLKIN (or to TCK for TRST).

Unused inputs should be tied or pulled to VDD or GND, except for ADDR31–0, DATA63–0, FLAG3–0, and inputs that have internal pull-up or pull-down resistors (\overline{PA} , ACK, \overline{BRST} , PAGE, CLKOUT, $\overline{MS3}$ –0, \overline{RDx} , \overline{WRx} , \overline{DMARx} , \overline{DMAGx} , DTx, DRx, TCLKx, RCLKx, LxDAT7–0, LxCLK, LxACK, TMS, \overline{TRST} and TDI)—these pins can be left floating. These pins have a logic-level hold circuit (only enabled on the ADSP-21160M with ID2–0 = 00x) that prevents input from floating internally.

The following symbols appear in the Type column of Table 2: A = Asynchronous, G = Ground, I = Input, O = Output, P = Power Supply, S = Synchronous, (A/D) = Active Drive, (O/D) = Open Drain, and T = Three-State (when SBTS is asserted, or when the ADSP-21160M is a bus slave).

Pin	Туре	Function
ADDR31–0	I/O/T	External Bus Address. The ADSP-21160M outputs addresses for external memory and peripherals on these pins. In a multiprocessor system, the bus master outputs addresses for read/writes of the internal memory or IOP registers of other ADSP-21160Ms. The ADSP-21160M inputs addresses when a host processor or multiprocessing bus master is reading or writing its internal memory or IOP registers. A keeper latch on the DSP's ADDR31–0 pins maintains the input at the level it was last driven (only enabled on the ADSP-21160M with ID2–0 = 00x).
DATA63-0	I/O/T	External Bus Data. The ADSP-21160M inputs and outputs data and instructions on these pins. Pull-up resistors on unused DATA pins are not necessary. A keeper latch on the DSP's DATA63-0 pins maintains the input at the level it was last driven (only enabled on the ADSP-21160M with ID2–0 = $00x$).
MS3-0	O/T	Memory Select Lines. These outputs are asserted (low) as chip selects for the corresponding banks of external memory. Memory bank size must be defined in the SYSCON control register. The $\overline{MS3-0}$ outputs are decoded memory address lines. In asyn- chronous access mode, the $\overline{MS3-0}$ outputs transition with the other address outputs. In synchronous access modes, the $\overline{MS3-0}$ outputs assert with the other address lines; however, they de-assert after the first CLKIN cycle in which ACK is sampled asserted.
RDL	I/O/T	Memory Read Low Strobe. RDL is asserted whenever ADSP-21160M reads from the low word of external memory or from the internal memory of other ADSP-21160Ms. External devices, including other ADSP-21160Ms, must assert RDL for reading from the low word of ADSP-21160M internal memory. In a multiprocessing system, RDL is driven by the bus master.
RDH	I/O/T	Memory Read High Strobe. RDH is asserted whenever ADSP-21160M reads from the high word of external memory or from the internal memory of other ADSP-21160Ms. External devices, including other ADSP-21160Ms, must assert RDH for reading from the high word of ADSP-21160M internal memory. In a multiprocessing system, RDH is driven by the bus master.
WRL	I/O/T	Memory Write Low Strobe. WRL is asserted when ADSP-21160M writes to the low word of external memory or internal memory of other ADSP-21160Ms. External devices must assert WRL for writing to ADSP-21160M's low word of internal memory. In a multiprocessing system, WRL is driven by the bus master.
WRH	I/O/T	Memory Write High Strobe. WRH is driven by the bus master. Memory Write High Strobe. WRH is asserted when ADSP-21160M writes to the high word of external memory or internal memory of other ADSP-21160Ms. External devices must assert WRH for writing to ADSP-21160M's high word of internal memory. In a multiprocessing system, WRH is driven by the bus master.
PAGE	O/T	DRAM Page Boundary. The ADSP-21160M asserts this pin to signal that an external DRAM page boundary has been crossed. DRAM page size must be defined in the ADSP-21160M's memory control register (WAIT). DRAM can only be implemented in external memory Bank 0; the PAGE signal can only be activated for Bank 0 accesses. In a multiprocessing system PAGE is output by the bus master. A keeper latch on the DSP's PAGE pin maintains the output at the level it was last driven (only enabled on the ADSP-21160M with ID2-0 = 00x).

Table 2.	Pin Function Descriptions	5
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Table 2. Pin Function Descriptions (Continued)

Pin	Туре	Function
BRST	I/O/T	Sequential Burst Access. BRST is asserted by ADSP-21160M or a host to indicate that data associated with consecutive addresses is being read or written. A slave device samples the initial address and increments an internal address counter after each transfer. The incremented address is not pipelined on the bus. If the burst access is a read from host to ADSP-21160M, ADSP-21160M automatically increments the address as long as BRST is asserted. BRST is asserted after the initial access of a burst
		transfer. It is asserted for every cycle after that, except for the last data request cycle (denoted by $\overline{\text{RDx}}$ or $\overline{\text{WRx}}$ asserted and $\overline{\text{BRST}}$ negated). A keeper latch on the DSP's $\overline{\text{BRST}}$ pin maintains the input at the level it was last driven (only enabled on the ADSP-21160M with ID2–0 = 00x).
ACK	I/O/S	Memory Acknowledge. External devices can de-assert ACK (low) to add wait states to
		an external memory access. ACK is used by I/O devices, memory controllers, or other peripherals to hold off completion of an external memory access. The ADSP-21160M deasserts ACK as an output to add wait states to a synchronous access of its internal memory. A keeper latch on the DSP's ACK pin maintains the input at the level it was last driven (only enabled on the ADSP-21160M with ID2–0 = $00x$).
<u>SBTS</u>	I/S	Suspend Bus and Three-State. External devices can assert SBTS (low) to place the external bus address, data, selects, and strobes in a high impedance state for the following cycle. If the ADSP-21160M attempts to access external memory while SBTS is asserted, the processor will halt and the memory access will not be completed until SBTS is deasserted. SBTS should only be used to recover from host processor and/or ADSP-21160M deadlock or used with a DRAM controller.
IRQ2-0	I/A	Interrupt Request Lines. These are sampled on the rising edge of CLKIN and may be either edge-triggered or level-sensitive.
FLAG3-0	I/O/A	Flag Pins. Each is configured via control bits as either an input or output. As an input, it can be tested as a condition. As an output, it can be used to signal external peripherals.
TIMEXP	0	Timer Expired. Asserted for four CLKIN cycles when the timer is enabled and TCOUNT decrements to zero.
HBR	I/A	Host Bus Request. Must be asserted by a host processor to request control of the ADSP-21160M's external bus. When $\overline{\text{HBR}}$ is asserted in a multiprocessing system, the ADSP-21160M that is bus master will relinquish the bus and assert $\overline{\text{HBG}}$. To relinquish the bus, the ADSP-21160M places the address, data, select, and strobe lines in a high impedance state. $\overline{\text{HBR}}$ has priority over all ADSP-21160M bus requests ($\overline{\text{BR6-1}}$) in a multiprocessing system.
HBG	I/O	Host Bus Grant. Acknowledges an HBR bus request, indicating that the host processor may take control of the external bus. HBG is asserted (held low) by the ADSP-21160M until HBR is released. In a multiprocessing system, HBG is output by the ADSP-21160M bus master and is monitored by all others.
CS	I/A	Chip Select. Asserted by host processor to select the ADSP-21160M.
REDY	O (O/D)	Host Bus Acknowledge. The ADSP-21160M deasserts REDY (low) to add waitstates to a host access when $\overline{\text{CS}}$ and $\overline{\text{HBR}}$ inputs are asserted.
DMAR1	I/A	DMA Request 1 (DMA Channel 11). Asserted by external port devices to request DMA services.
DMAR2	I/A	DMA Request 2 (DMA Channel 12). Asserted by external port devices to request DMA services.
ID2-0	I	Multiprocessing ID. Determines which multiprocessing bus request ($\overline{BR1}$ – $\overline{BR6}$) is used by ADSP-21160M. ID = 001 corresponds to $\overline{BR1}$, ID = 010 corresponds to $\overline{BR2}$, and so on. Use ID = 000 or ID = 001 in single-processor systems. These lines are a system configuration selection which should be hardwired or only changed at reset.
DMAG1	O/T	DMA Grant 1 (DMA Channel 11). Asserted by ADSP-21160M to indicate that the requested DMA starts on the next cycle. Driven by bus master only.

Pin	Туре	Function
DMAG2	O/T	DMA Grant 2 (DMA Channel 12). Asserted by ADSP-21160M to indicate that the
		requested DMA starts on the next cycle. Driven by bus master only.
BR6-1	I/O/S	Multiprocessing Bus Requests. Used by multiprocessing ADSP-21160Ms to arbitrate
		for bus mastership. An ADSP-21160M only drives its own BRx line (corresponding to
		the value of its ID2–0 inputs) and monitors all others. In a multiprocessor system with
		less than six ADSP-21160Ms, the unused \overline{BRx} pins should be pulled high; the
		processor's own \overline{BRx} line must not be pulled high or low because it is an output.
RPBA	I/S	Rotating Priority Bus Arbitration Select. When RPBA is high, rotating priority for
		multiprocessor bus arbitration is selected. When RPBA is low, fixed priority is selected.
		This signal is a system configuration selection which must be set to the same value on
		every ADSP-21160M. If the value of RPBA is changed during system operation, it must
		be changed in the same CLKIN cycle on every ADSP-21160M.
PA	I/O/T	Priority Access. Asserting its PA pin allows an ADSP-21160M bus slave to interrupt
		background DMA transfers and gain access to the external bus. PA is connected to all
		ADSP-21160Ms in the system. If access priority is not required in a system, the PA pin
		should be left unconnected.
DTx	0	Data Transmit (Serial Ports 0, 1). Each DT pin has a 50 k Ω internal pull-up resistor.
DRx	I	Data Receive (Serial Ports 0, 1). Each DR pin has a 50 k Ω internal pull-up resistor.
TCLKx	I/O	Transmit Clock (Serial Ports 0, 1). Each TCLK pin has a 50 k Ω internal
	10	pull-up resistor.
RCLKx	I/O	Receive Clock (Serial Ports 0, 1). Each RCLK pin has a 50 k Ω internal pull-up resistor.
TFSx	I/O	Transmit Frame Sync (Serial Ports 0, 1).
RFSx	I/O	Receive Frame Sync (Serial Ports 0, 1).
LxDAT7-0	I/O	Link Port Data (Link Ports 0–5). Each LxDAT pin has a 50 k Ω internal pull-down
	10	resistor that is enabled or disabled by the LPDRD bit of the LCTL0–1 register.
LxCLK	I/O	Link Port Clock (Link Ports 0–5). Each LxCLK pin has a 50 k Ω internal pull-down
	10	resistor that is enabled or disabled by the LPDRD bit of the LCTL0–1 register.
LxACK	I/O	Link Port Acknowledge (Link Ports 0–5). Each LxACK pin has a 50 k Ω internal
	10	pull-down resistor that is enabled or disabled by the LPDRD bit of the LCOM register.
EBOOT	Ι	EPROM Boot Select. For a description of how this pin operates, see Table 3. This
22001	-	signal is a system configuration selection that should be hardwired.
LBOOT	Ι	Link Boot. For a description of how this pin operates, see Table 3. This signal is a
		system configuration selection that should be hardwired.
BMS	I/O/T	Boot Memory Select. Serves as an output or input as selected with the EBOOT and
Divio	1,0,1	LBOOT pins; see Table 3. This input is a system configuration selection that should
		be hardwired.
CLKIN	T	Local Clock In. CLKIN is the ADSP-21160M clock input. The ADSP-21160M
		external port cycles at the frequency of CLKIN. The instruction cycle rate is a multiple
		of the CLKIN frequency; it is programmable at power-up. CLKIN may not be halted,
		changed, or operated below the specified frequency.
CLK_CFG3-0	Ι	Core/CLKIN Ratio Control. ADSP-21160M core clock (instruction cycle) rate is equal
	1	to n × CLKIN where n is user-selectable to 2, 3, or 4, using the CLK_CFG3–0 inputs.
		For clock configuration definitions, see the <u>RESET</u> & CLKIN section of the System
		Design chapter of the ADSP-21160 SHARC DSP Hardware Reference manual.
CLKOUT	O/T	Local Clock Out. CLKOUT is driven at the CLKIN frequency by the current bus
CLRUUI	0/1	master. This output is three-stated when the ADSP-21160M is not the bus master, or
		when the host controls the bus (HBG asserted). A keeper latch on the DSP's CLKOUT
		pin maintains the output at the level it was last driven (only enabled on the
		ADSP-21160M with $ID2-0 = 00x$).
RESET	I/A	Processor Reset. Resets the ADSP-21160M to a known state and begins execution at $\frac{1}{2}$
NEOL I	1/11	the program memory location specified by the hardware reset vector address. The
		RESET input must be asserted (low) at power-up.
	1	interest input must be asserted (10w) at power-up.

Table 2. Pin Function Descriptions (Continued)

Pin	Туре	Function	
TCK	Ι	Test Clock (JTAG). Provides a clock for JTAG boundary scan.	
TMS	I/S	Test Mode Select (JTAG). Used to control the test state machine. TMS has a 20 k Ω internal pull-up resistor.	
TDI	I/S	Test Data Input (JTAG). Provides serial data for the boundary scan logic. TDI has a 20 k Ω internal pull-up resistor.	
TDO	0	Test Data Output (JTAG). Serial scan output of the boundary scan path.	
TRST	I/A	Test Reset (JTAG). Resets the test state machine. TRST must be asserted (pulsed low) after power-up or held low for proper operation of the ADSP-21160M. TRST has a 20 k Ω internal pull-up resistor.	
EMU	O (O/D)	Emulation Status. Must be connected to the ADSP-21160M emulator target board connector only. EMU has a 50 k Ω internal pull-up resistor.	
CIF	O/T	Core Instruction Fetch. Signal is active low when an external instruction fetch is performed. Driven by bus master only. Three-state when host is bus master.	
V _{DDINT}	Р	Core Power Supply. Nominally 2.5 V dc and supplies the DSP's core processor (40 pins).	
V _{DDEXT}	Р	I/O Power Supply. Nominally 3.3 V dc (46 pins).	
AV_{DD}	Р	Analog Power Supply. Nominally 2.5 V dc and supplies the DSP's internal PLL (clock generator). This pin has the same specifications as V_{DDINT} , except that added filtering circuitry is required. For more information, see Power Supplies on page 6.	
AGND	G	Analog Power Supply Return.	
GND	G	Power Supply Return. (83 pins)	
NC		Do Not Connect. Reserved pins that must be left open and unconnected (5 pins).	

Table 2. Pin Function Descriptions (Continued)

Table 3. Boot Mode Selection

EBOOT	LBOOT	BMS	Booting Mode
1	0	Output	EPROM (Connect BMS to EPROM chip select.)
0	0	1 (Input)	Host Processor
0	1	1 (Input)	Link Port
0	0	0 (Input)	No Booting. Processor executes from external memory.
0	1	0 (Input)	Reserved
1	1	x (Input)	Reserved

ADSP-21160M SPECIFICATIONS

RECOMMENDED OPERATING CONDITIONS

Signal	K Grade Parameter ¹	Min	Max	Unit
V _{DDINT}	Internal (Core) Supply Voltage	2.37	2.63	V
AV_{DD}	Analog (PLL) Supply Voltage	2.37	2.63	V
V_{DDEXT}	External (I/O) Supply Voltage	3.13	3.47	V
V_{IH1}	High Level Input Voltage ² , @ V _{DDEXT} =Max	2.2	V_{DDEXT} +0.5	V
V_{IH2}	High Level Input Voltage ³ , @ V _{DDEXT} =Max	2.3	V_{DDEXT} +0.5	V
V_{IL}	Low Level Input Voltage ^{2,3} , @ V _{DDEXT} =Min	-0.5	0.8	V
T_{CASE}	Case Operating Temperature ⁴	0	85	°C

¹ Specifications subject to change without notice.

²Applies to input and bidirectional pins: DATA63–0, ADDR31–0, RDx, WRx, ACK, SBTS, IRQ2–0, FLAG3–0, HBG, CS, DMARI, DMAR2, BR6–1, ID2–0, RPBA, PA, BRST, TFS0, TFS1, RFS0, RFS1, LxDAT3–0, LxCLK, LxACK, EBOOT, LBOOT, BMS, TMS, TDI, TCK, HBR, DR0, DR1, TCLK0, TCLK1, RCLK0, RCLK1.

³Applies to input pins: CLKIN, RESET, TRST.

⁴See Environmental Conditions on page 45 for information on thermal specifications.

ELECTRICAL CHARACTERISTICS

Parameter ¹		Test Conditions	Min	Max	Unit
V _{OH}	High Level Output Voltage ²	(a) V_{DDEXT} = Min, I_{OH} = -2.0 mA ³	2.4		V
V_{OL}	Low Level Output Voltage ²	@ V _{DDEXT} = Min, I _{OL} = 4.0 mA ³		0.4	V
\mathbf{I}_{IH}	High Level Input Current ^{4,5,6}	\hat{a} V _{DDEXT} = Max, V _{IN} = V _{DD} Max		10	μA
\mathbf{I}_{IL}	Low Level Input Current ⁴	$@V_{DDEXT} = Max, V_{IN} = 0 V$		10	μA
$\mathbf{I}_{\mathrm{ILPU1}}$	Low Level Input Current Pull-Up1 ⁵	@ V _{DDEXT} =Max, V _{IN} =0 V		250	μA
$I_{\rm ILPU2}$	Low Level Input Current Pull-Up2 ⁶	@ V _{DDEXT} =Max, V _{IN} =0 V		500	μA
I _{OZH}	Three-State Leakage Current ^{7,8,9,10}	$@V_{DDEXT} = Max, V_{IN} = V_{DD} Max$		10	μA
I _{OZL}	Three-State Leakage Current ⁷	\hat{a} V _{DDEXT} = Max, V _{IN} = 0 V		10	μA
$\mathbf{I}_{\text{OZHPD}}$	Three-State Leakage Current Pull-Down ¹⁰	@ V_{DDEXT} = Max, V_{IN} = V_{DD} Max		250	μА
$\mathbf{I}_{\text{OZLPU1}}$	Three-State Leakage Current Pull-Up1 ⁸	(a) V_{DDEXT} = Max, V_{IN} = 0 V		250	μА
I _{OZLPU2}	Three-State Leakage Current Pull-Up2 ⁹	@ V_{DDEXT} = Max, V_{IN} = 0 V		500	μА
I _{OZHA}	Three-State Leakage Current ¹¹	$@V_{DDEXT} = Max, V_{IN} = V_{DD} Max$		25	μA
I _{OZLA}	Three-State Leakage Current ¹¹	$\overset{\frown}{@}$ V _{DDEXT} = Max, V _{IN} =0 V		4	mA
$\mathbf{I}_{\text{DD-INPEAK}}$	Supply Current (Internal) ¹²	$t_{CCLK} = 12.5 \text{ ns}, V_{DDINT} = Max$		1400	mA
$\mathbf{I}_{\text{DD-INHIGH}}$	Supply Current (Internal) ¹³	t_{CCLK} =12.5 ns, V_{DDINT} =Max		875	mA
$\mathbf{I}_{\text{DD-INLOW}}$	Supply Current (Internal) ¹⁴	t_{CCLK} =12.5 ns, V_{DDINT} =Max		625	mA
$\mathbf{I}_{\text{DD-IDLE}}$	Supply Current (Idle) ¹⁵	t_{CCLK} =12.5 ns, V_{DDINT} =Max		80	mA
AI_{DD}	Supply Current (Analog) ¹⁶	$@AV_{DD} = Max$		10	mA
C_{IN}	Input Capacitance ^{17,18}	f_{IN} =1 MHz, T_{CASE} =25°C, V_{IN} =2.5 V		4.7	pF

¹ Specifications subject to change without notice.

²Applies to output and bidirectional pins: DATA63–0, ADDR31–0, MS3–0, RDx, WRx, PAGE, CLKOUT, ACK, FLAG3–0, TIMEXP, HBG, REDY, <u>DMAG1</u>, <u>DMAG2</u>, <u>BR6–1</u>, <u>PA</u>, <u>BRST</u>, <u>CIF</u>, DT0, DT1, TCLK0, TCLK1, RCLK0, RCLK1, TFS0, TFS1, RFS0, RFS1, LxDAT3–0, LxCLK, LxACK, BMS</u>, TDO, <u>EMU</u>.

³See Output Drive Currents on page 42 for typical drive current capabilities.

⁴Applies to input pins: ACK, SBTS, IRQ2-0, HBR, CS, ID2-0, RPBA, EBOOT, LBOOT, CLKIN, RESET, TCK, CLK_CFG3-0.

⁵Applies to input pins with internal pull-ups: DR0, DR1.

⁶Applies to input pins with internal pull-ups: DMARx, TMS, TDI, TRST.

⁷Applies to three-statable pins: DATA63-0, ADDR31-0, PAGE, CLKOUT, ACK, FLAG3-0, REDY, HBG, BMS, BR6-1, TFSx, RFSx, TDO.

⁸Applies to three-statable pins with internal pull-ups: DTx, TCLKx, RCLKx, EMU.

⁹Applies to three-statable pins with internal pull-ups: MS3–0, RDx, WRx, DMAGx, PA, CIF.

¹⁰Applies to three-statable pins with internal pull-downs: LxDAT7-0, LxCLK, LxACK.

¹¹Applies to ACK pulled up internally with 2 k Ω during reset or ID2–0 = 00x.

¹²The test program used to measure I_{DD-INPEAK} represents worst case processor operation and is not sustainable under normal application conditions. Actual internal power measurements made using typical applications are less than specified. For more information, see Power Dissipation on page 42.

¹³I_{DDINHIGH} is a composite average based on a range of high activity code. For more information, see Power Dissipation on page 42.

¹⁴I_{DDINLOW} is a composite average based on a range of low activity code. For more information, see Power Dissipation on page 42.

¹⁵Idle denotes ADSP-21160M state during execution of IDLE instruction. For more information, see Power Dissipation on page 42.

¹⁶Characterized, but not tested.

¹⁷Applies to all signal pins.

¹⁸Guaranteed, but not tested.

ABSOLUTE MAXIMUM RATINGS

Internal (Core) Supply Voltage $(V_{DDINT})^1 \dots -0.3 \text{ V to } +3.0 \text{ V}$
Analog (PLL) Supply Voltage (A_{VDD}) 0.3 V to +3.0 V
External (I/O) Supply Voltage (V_{DDEXT}) –0.3 V to +4.6 V
Input Voltage+0.5 V to V_{DDEXT} +0.5 V
Output Voltage Swing $\dots -0.5$ V to V _{DDEXT} +0.5 V
Load Capacitance
Storage Temperature Range65°C to +150°C
Lead Temperature (5 seconds) 185°C

¹Stresses greater than those listed above may cause permanent damage to the device. These are stress ratings only. Functional operation of the device at these or any other conditions greater than those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ESD SENSITIVITY

CAUTION:

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000V readily accumulate on the human body and test equipment and can discharge without detection. Although the ADSP-21160M features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high-energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



Timing Specifications

The ADSP-21160M's internal clock switches at higher frequencies than the system input clock (CLKIN). To generate the internal clock, the DSP uses an internal phase-locked loop (PLL). This PLL-based clocking minimizes the skew between the system clock (CLKIN) signal and the DSP's internal clock (the clock source for the external port logic and I/O pads).

The ADSP-21160M's internal clock (a multiple of CLKIN) provides the clock signal for timing internal memory, processor core, link ports, serial ports, and external port (as required for read/write strobes in asynchronous access mode). During reset, program the ratio between the DSP's internal clock frequency and external (CLKIN) clock frequency with the CLK_CFG3–0 pins. Even though the internal clock is the clock source for the external port, the external port clock always switches at the CLKIN frequency. To determine switching frequencies for the serial and link ports, divide down the internal clock, using the programmable divider control of each port (TDIVx/RDIVx for the serial ports and LxCLKD1–0 for the link ports).

Note the following definitions of various clock periods that are a function of CLKIN and the appropriate ratio control:

- t_{CCLK} = (t_{CK}) / CR
- $t_{LCLK} = (t_{CCLK}) \times LR$
- $t_{SCLK} = (t_{CCLK}) \times SR$

Where:

- LCLK = Link Port Clock
- SCLK = Serial Port Clock
- t_{CK} = CLKIN Clock Period
- t_{CCLK} = (Processor) Core Clock Period
- t_{LCLK} = Link Port Clock Period
- t_{SCLK} = Serial Port Clock Period
- CR = Core/CLKIN Ratio (2, 3, or 4:1, determined by CLK_CFG3–0 at reset)
- LR = Link Port/Core Clock Ratio (1, 2, 3, or 4:1, determined by LxCLKD)
- SR = Serial Port/Core Clock Ratio (wide range, determined by ×CLKDIV)

Use the exact timing information given. Do not attempt to derive parameters from the addition or subtraction of others. While addition or subtraction would yield meaningful results for an individual device, the values given in this data sheet reflect statistical variations and worst cases. Consequently, it is not meaningful to add parameters to derive longer times.

See Figure 32 under Test Conditions for voltage reference levels.

Switching Characteristics specify how the processor changes its signals. Circuitry external to the processor must be designed for compatibility with these signal characteristics. Switching characteristics describe what the processor will do in a given circumstance. Use switching characteristics to ensure that any timing requirement of a device connected to the processor (such as memory) is satisfied.

Timing Requirements apply to signals that are controlled by circuitry external to the processor, such as the data input for a read operation. Timing requirements guarantee that the processor operates correctly with other devices.

Clock Input

Table 4. Clock Input

		80 MHz		T.L	
Parameter			Min	Max	- Unit
Timing Req	juirements:				
t _{ck}	CLKIN Period		25	80	ns
t _{CKL}	CLKIN Width Low		10.5	40	ns
t _{ckh}	CLKIN Width High		10.5	40	ns
$t_{\rm CKRF}$	CLKIN Rise/Fall (0.4V-2.0V)			3	ns

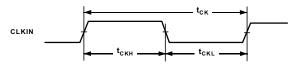


Figure 10. Clock Input

Reset

Table 5. Reset

Parameter			Max	Unit
Timing Re	quirements:			
t _{wrst}	RESET Pulsewidth Low ¹	$4t_{CK}$		ns
t _{srst}	RESET Setup Before CLKIN High ²	8		ns

¹Applies after the power-up sequence is complete. At power-up, the processor's internal phase-locked loop requires no more than 100 ms while **RESET** is low, assuming stable VDD and CLKIN (not including start-up time of external clock oscillator).

²Only required if multiple ADSP-21160Ms must come out of reset synchronous to CLKIN with program counters (PC) equal. Not required for multiple ADSP-21160Ms communicating over the shared bus (through the external port), because the bus arbitration logic automatically synchronizes itself after reset.

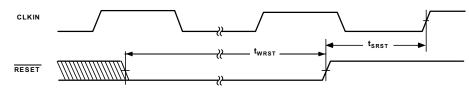


Figure 11. Reset

Interrupts

Table 6. Interrupts

Parameter		Min	Max	Unit
Timing Re	quirements:			
t _{SIR}	IRQ2–0 Setup Before CLKIN High ¹	6		ns
t _{HIR}	IRQ2–0 Hold After CLKIN High ¹	0		ns
$t_{\rm IPW}$	$\overline{\text{IRQ2-0}}$ Pulsewidth ²	$2 + t_{CK}$		ns

¹Only required for IRQx recognition in the following cycle.

 $^2\mbox{Applies}$ only if t_{SIR} and t_{HIR} requirements are not met.

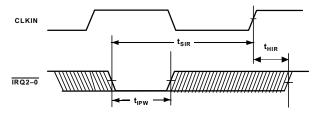


Figure 12. Interrupts

Timer

Table 7. Timer

7 ns
/



Figure 13. Timer

Flags

Table 8. Flags

Parameter	r	Min	Max	Unit
Timing Req	puirements:			
t _{SFI}	FLAG3–0 IN Setup Before CLKIN High ¹	4		ns
t _{HFI}	FLAG3–0 IN Hold After CLKIN High ¹	1		ns
t _{DWRFI}	FLAG3–0 IN Delay After RDx/WRx Low ¹		12	ns
t _{HFIWR}	FLAG3-0 IN Hold After RDx/WRx Deasserted ¹	0		ns
Switching (Characteristics:			
t _{DFO}	FLAG3–0 OUT Delay After CLKIN High		9	ns
t _{HFO}	FLAG3–0 OUT Hold After CLKIN High	1		ns
t _{DFOE}	CLKIN High to FLAG3-0 OUT Enable	1		ns
t _{DFOD}	CLKIN High to FLAG3-0 OUT Disable		5	ns

¹Flag inputs meeting these setup and hold times for instruction cycle N will affect conditional instructions in instruction cycle N+2.

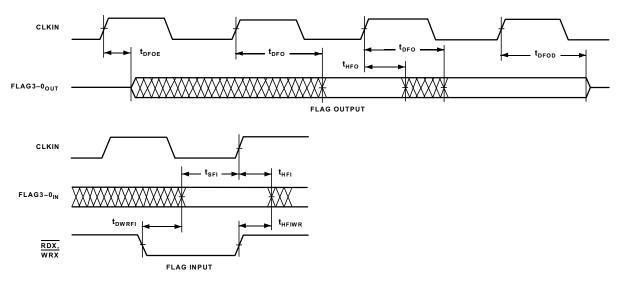


Figure 14. Flags

Memory Read—Bus Master

Use these specifications for asynchronous interfacing to memories (and memory-mapped peripherals) without reference to CLKIN. These specifications apply when the ADSP-21160M is the bus master accessing external memory space in asynchronous access mode. Note that timing for ACK, DATA, $\overline{\text{RDx}}$, $\overline{\text{WRx}}$, and $\overline{\text{DMAG}}$ strobe timing parameters only applies to asynchronous access mode.

Table 9. Memory Read—Bus Master	Table 9.	Memory	Read-	-Bus	Master
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Parameter	r	Min	Max	Unit
Timing Req	wirements:			
t_{DAD}	Address, <u>CIF</u> , Selects Delay to Data Valid ^{1,2}		$t_{cK} - 0.25 t_{cCLK} - 11 + W$	ns
t _{DRLD}	$\overline{\text{RDx}}$ Low to Data Valid ^{1,3}		$0.75t_{CK} - 11 + W$	ns
t _{HDA}	Data Hold from Address, Selects ⁴	0		ns
t _{sds}	Data Setup to \overline{RDx} High ¹	8		ns
t _{HDRH}	Data Hold from \overline{RDx} High ^{3,4}	1		ns
t _{DAAK}	ACK Delay from Address, Selects ^{2,5}		$t_{ck} - 0.5 t_{cclk} - 12 + W$	ns
t _{DSAK}	ACK Delay from RDx Low ^{3,5}		$t_{CK} - 0.75 t_{CCLK} - 11 + W$	ns
t _{sakc}	ACK Setup to CLKIN ^{3,5}	$0.5t_{\text{CCLK}}+3$		ns
t _{HAKC}	ACK Hold After CLKIN ³	1		ns
Switching (Characteristics:			
t _{DRHA}	Address, CIF, Selects Hold After RDx High ³	$0.25t_{\text{CCLK}}-1+H$		ns
t _{DARL}	Address, $\overline{\text{CIF}}$, Selects to $\overline{\text{RDx}}$ Low ²	$0.25t_{\text{CCLK}}-3$		ns
t _{RW}	$\overline{\text{RDx}}$ Pulse width ³	$t_{CK} = 0.5 t_{CCLK} = 1 + W$		ns
t _{RWR}	$\overline{\text{RDx}}$ High to $\overline{\text{WRx}}$, $\overline{\text{RDx}}$, $\overline{\text{DMAGx}}$ Low ³	$0.5t_{\text{CCLK}}-1+HI$		ns

W = (number of wait states specified in WAIT register) \times t_{CK}.

 $HI = t_{CK}$ (if an address hold cycle or bus idle cycle occurs, as specified in WAIT register; otherwise HI = 0).

 $H = t_{CK}$ (if an address hold cycle occurs as specified in WAIT register; otherwise H = 0).

¹Data Delay/Setup: User must meet t_{DAD}, t_{DRLD}, or t_{SDS}.

²The falling edge of \overline{MSx} , \overline{BMS} is referenced.

³Note that timing for ACK, DATA, RDx, WRx, and DMAG strobe timing parameters only applies to asynchronous access mode.

⁴Data Hold: User must meet t_{HDA} or t_{HDAH} in asynchronous access mode. See Example System Hold Time Calculation on page 44 for the calculation of hold times given capacitive and dc loads.

⁵ACK Delay/Setup: User must meet t_{DAAK}, t_{DSAK}, or t_{SAKC} for deassertion of ACK (Low), all three specifications must be met for assertion of ACK (High).

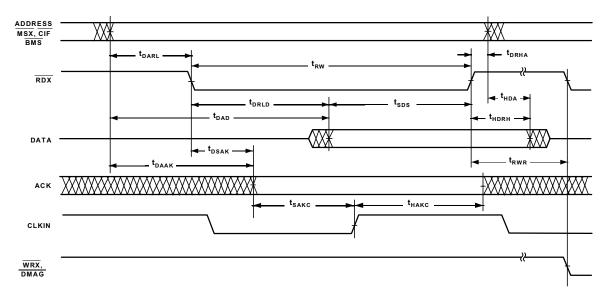


Figure 15. Memory Read—Bus Master

Memory Write-Bus Master

Use these specifications for asynchronous interfacing to memories (and memory-mapped peripherals) without reference to CLKIN. These specifications apply when the ADSP-21160M is the bus master accessing external

Table 10.	Memory	Write-Bu	is Master
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memory space in asynchronous access mode. Note that timing for ACK, DATA, $\overline{\text{RDx}}$, $\overline{\text{WRx}}$, and $\overline{\text{DMAG}}$ strobe timing parameters only applies to asynchronous access mode.

Parameter		Min	Max	Unit
Timing Requ	irements:			
t _{DAAK}	ACK Delay from Address, Selects ^{1,2}		$t_{CK} = 0.5 t_{CCLK} = 12 + W$	ns
t _{DSAK}	ACK Delay from \overline{WRx} Low ^{1,3}		$t_{CK} = 0.75 t_{CCLK} = 11 + W$	ns
t _{sakc}	ACK Setup to CLKIN ^{1,3}	$0.5t_{\text{CCLK}}+3$		ns
t _{HAKC}	ACK Hold After CLKIN ^{1,3}	1		ns
Switching Ch	haracteristics:			
t _{DAWH}	Address, $\overline{\text{CIF}}$, Selects to $\overline{\text{WRx}}$	$t_{CK} = -0.25 t_{CCLK} = -3 + W$		ns
2.1.011	Deasserted ^{2,3}			
t _{DAWL}	Address, $\overline{\text{CIF}}$, Selects to $\overline{\text{WRx}}$ Low ²	$0.25t_{\text{CCLK}}-3$		ns
t _{ww}	$\overline{\text{WRx}}$ Pulse width ³	$t_{CK} - 0.5 t_{CCLK} - 1 + W$		ns
t _{DDWH}	Data Setup before WRx High ³	$t_{CK} - 0.25 t_{CCLK} - 12.5 + W$		ns
t _{DWHA}	Address Hold after WRx Deasserted ³	$0.25t_{\text{CCLK}} - 1 + H$		ns
t _{DWHD}	Data Hold after WRx Deasserted ³	$0.25t_{\text{CCLK}}-1+H$		ns
t _{DATRWH}	Data Disable after WRx Deasserted ^{3,4}	$0.25t_{\text{CCLK}}-2+H$	$0.25t_{\text{CCLK}}$ +2+H	ns
t _{wwR}	$\overline{\text{WRx}}$ High to $\overline{\text{WRx}}$, $\overline{\text{RDx}}$, $\overline{\text{DMAGx}}$	$0.5t_{\text{CCLK}} - 1 + \text{HI}$		ns
	Low ³			
t _{DDWR}	Data Disable before \overline{WRx} or \overline{RDx} Low	$0.25t_{\text{CCLK}} - 1 + I$		ns
$t_{\rm WDE}$	WRx Low to Data Enabled	$-0.25t_{CCLK}-1$		ns

W = (number of wait states specified in WAIT register) × t_{CK} .

 $H = t_{CK}$ (if an address hold cycle occurs, as specified in WAIT register; otherwise H = 0).

 $HI = t_{CK}$ (if an address hold cycle or bus idle cycle occurs, as specified in WAIT register; otherwise HI = 0).

 $I = t_{CK}$ (if a bus idle cycle occurs, as specified in WAIT register; otherwise I = 0).

¹ACK Delay/Setup: User must meet t_{DAAK} or t_{DSAK} or t_{SAKC} for deassertion of ACK (Low), all three specifications must be met for assertion of ACK (High). ²The falling edge of MSx, BMS is referenced.

³Note that timing for ACK, DATA, RDx, WRx, and DMAG strobe timing parameters only applies to asynchronous access mode.

⁴See Example System Hold Time Calculation on page 44 for calculation of hold times given capacitive and dc loads.

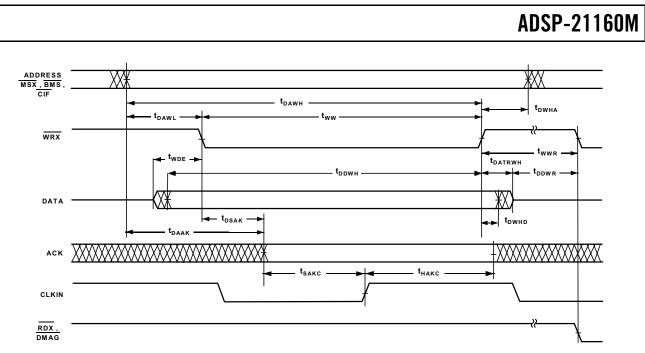


Figure 16. Memory Write—Bus Master

Synchronous Read/Write—Bus Master

Use these specifications for interfacing to external memory systems that require CLKIN—relative timing or for accessing a slave ADSP-21160M (in multiprocessor memory space). These synchronous switching characteristics are also valid during asynchronous memory reads and writes except where noted (see Memory Read—Bus Master on page 19 and Memory Write—Bus Master on page 20).

When accessing a slave ADSP-21160M, these switching characteristics must meet the slave's timing requirements for synchronous read/writes (see Synchronous Read/Write—Bus Slave on page 24). The slave ADSP-21160M must also meet these (bus master) timing requirements for data and acknowledge setup and hold times.

Table 11. Synchronous Read/Write-Bus Master

Parameter		Min	Max	Unit
Timing Requ	urements:			
t _{ssdati}	Data Setup Before CLKIN ¹	5.5		ns
t _{hsdati}	Data Hold After CLKIN ¹	1		ns
t _{sackc}	ACK Setup Before CLKIN ¹	$0.5t_{\text{CCLK}}+3$		ns
t _{HACKC}	ACK Hold After CLKIN ¹	1		ns
Switching C	haracteristics:			
t _{DADDO}	Address, MSx, BMS, BRST, CIF Delay After CLKIN		10	ns
t _{HADDO}	Address, MSx, BMS, BRST, CIF Hold After CLKIN	1.5		ns
t _{DPGO}	PAGE Delay After CLKIN	1.5	11	ns
t _{DRDO}	RDx High Delay After CLKIN ¹	$0.25t_{\text{CCLK}}-1$	$0.25t_{\text{CCLK}}+9$	ns
t _{DWRO}	WRx High Delay After CLKIN ¹	$0.25t_{\text{CCLK}} - 1$	$0.25t_{\text{CCLK}}+9$	ns
t _{DRWL}	RDx/WRx Low Delay After CLKIN	$0.25t_{\text{CCLK}}-1$	$0.25t_{\text{CCLK}}+9$	ns
t _{DDATO}	Data Delay After CLKIN		12.5	ns
t _{HDATO}	Data Hold After CLKIN	1.5		ns
t _{DACKMO}	ACK Delay After CLKIN ²	$0.25t_{CCLK}+3$	$0.25t_{\text{CCLK}}+9$	ns
t _{ACKMTR}	ACK Disable Before CLKIN ²	$0.25t_{\text{CCLK}}-3$		ns
t _{DCKOO}	CLKOUT Delay After CLKIN	2	5	ns
t _{ckop}	CLKOUT Period	t _{ck} -1	$t_{CK}^{3} + 1$	ns
t _{ckwh}	CLKOUT Width High	$t_{\rm CK}/2\!-\!2$	$t_{CK}/2+2^{3}$	ns
t _{ckwL}	CLKOUT Width Low	$t_{\rm CK}/2\!-\!2$	$t_{CK}/2+2^3$	ns

¹Note that timing for ACK, DATA, RDx, WRx, and DMAG strobe timing parameters only applies to synchronous access mode.

²Applies to broadcast write, master precharge of ACK.

³Applies only when the DSP drives a bus operation; CLKOUT held inactive or three-state otherwise, For more information, see the System Design chapter in the *ADSP-2116x SHARC DSP Hardware Reference*.

ADSP-21160M CLKIN tckop t_{скwн} t_{DCKOO} tCKWL CLKOUT $\mathbf{t}_{\mathsf{DADDO}}$ t_{HADDO} ADDRESS MSX, BRST, CIF γ t_{DPGO} PAGE t_{HACKC} t_{sackc} ACK (IN) \times t_{dackmo} **t**_{ackmtr} ACK (OUT) READ CYCLE t_{DRWL} --t_{DRDO} -RDX t_{ssdati} → t_{hsdati} DATA XXXX ¥XXXX (IN) WRITE CYCLE t_{dwro} t_{DRWL} WRX t_{HDATO} t_{ddato} Г DATA (OUT) ¥XXXXXXXXXXXXXXX (XXXX)

Figure 17. Synchronous Read/Write-Bus Master

Synchronous Read/Write—Bus Slave

Use these specifications for ADSP-21160M bus master accesses of a slave's IOP registers or internal memory (in multiprocessor memory space). The bus master must meet these (bus slave) timing requirements.

Parameter		Min	Max	Unit
Timing Req	uirements:			
t _{saddi}	Address, BRST Setup Before CLKIN	5		ns
t _{haddi}	Address, BRST Hold After CLKIN	1		ns
t _{srwi}	RDx/WRx Setup Before CLKIN	5		ns
t _{HRWI}	RDx/WRx Hold After CLKIN	1		ns
t _{ssdati}	Data Setup Before CLKIN	5.5		ns
t _{hsdati}	Data Hold After CLKIN	1		ns
Switching (Characteristics:			
t _{DDATO}	Data Delay After CLKIN		12.5	ns
t _{HDATO}	Data Hold After CLKIN	1.5		ns
t _{DACKC}	ACK Delay After CLKIN		10	ns
t _{HACKO}	ACK Hold After CLKIN	1.5		ns

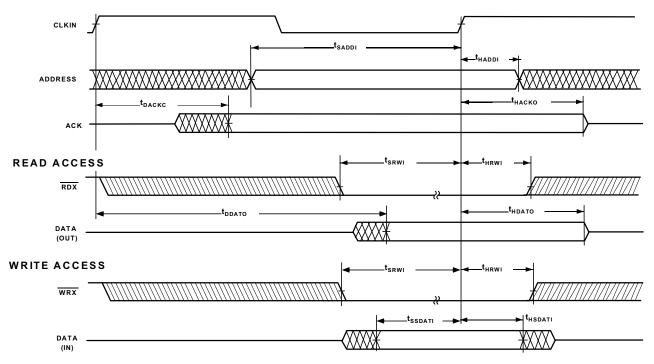


Figure 18. Synchronous Read/Write-Bus Slave

Multiprocessor Bus Request and Host Bus Request

Use these specifications for passing of bus mastership between multiprocessing ADSP-21160Ms (\overline{BRx}) or a host processor (\overline{HBR} , \overline{HBG}).

Table 13.	Multiprocessor	Bus Request and	Host Bus Request
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Parameter		Min	Max	Unit
Timing Requ	uirements:			
t _{HBGRCSV}	HBG Low to RDx/WRx/CS Valid		19	ns
t _{shbri}	HBR Setup Before CLKIN ¹	6		ns
t _{HHBRI}	HBR Hold After CLKIN ¹	1		ns
t _{shbgi}	HBG Setup Before CLK/=']IN	6		ns
t _{HHBGI}	HBG Hold After CLKIN High	1		ns
t _{sbri}	BRx, PA Setup Before CLKIN	9		ns
t _{HBRI}	BRx, PA Hold After CLKIN High	1		ns
t _{spai}	PA Setup Before CLKIN	9		ns
t _{HPAI}	PA Hold After CLKIN High	1		ns
t _{srpbai}	RPBA Setup Before CLKIN	6		ns
t _{hrpbai}	RPBA Hold After CLKIN	2		ns
Switching C	Tharacteristics:			
t _{DHBGO}	HBG Delay After CLKIN		7	ns
t _{HHBGO}	HBG Hold After CLKIN	2		ns
t _{DBRO}	BRx Delay After CLKIN		8	ns
t _{HBRO}	BRx Hold After CLKIN	1.5		ns
t _{DPASO}	PA Delay After CLKIN, Slave		8	ns
t _{TRPAS}	PA Disable After CLKIN, Slave	1.5		ns
t _{DPAMO}	PA Delay After CLKIN, Master		$0.25t_{\text{CCLK}}+9$	ns
t _{PATR}	PA Disable Before CLKIN, Master	$0.25t_{\text{CCLK}}-5$		ns
t _{DRDYCS}	REDY (O/D) or (A/D) Low from $\overline{\text{CS}}$ and $\overline{\text{HBR}}$ Low ²		$0.5t_{CK}$	ns
t _{TRDYHG}	REDY (O/D) Disable or REDY (A/D) High from $\overline{\text{HBG}}^2$	t _{CK} +25		ns
t _{ARDYTR}	REDY (A/D) Disable from $\overline{\text{CS}}$ or $\overline{\text{HBR}}$ High ²		11	ns

¹Only required for recognition in the current cycle.

 $^{2}(O/D)$ = open drain, (\bar{A}/D) = active drive.

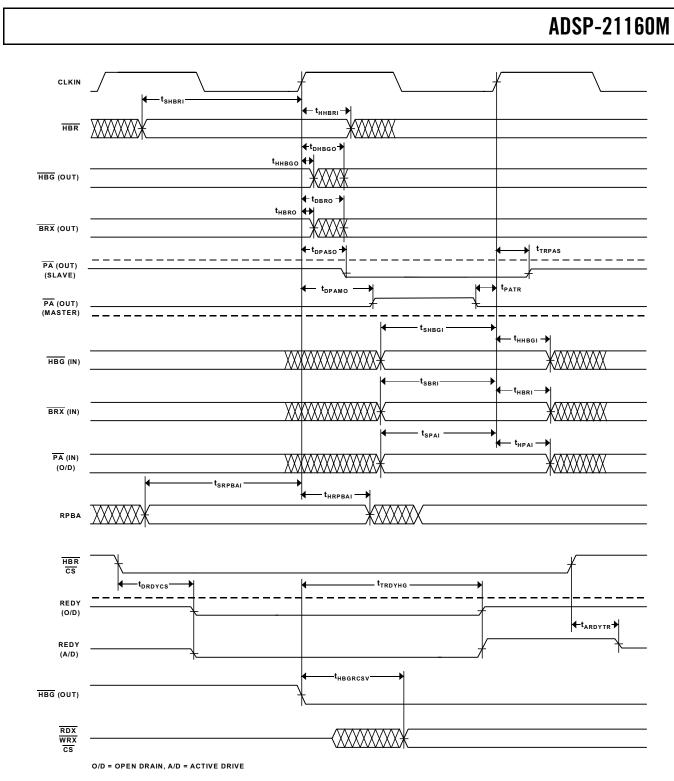


Figure 19. Multiprocessor Bus Request and Host Bus Request

Asynchronous Read/Write—Host to ADSP-21160M

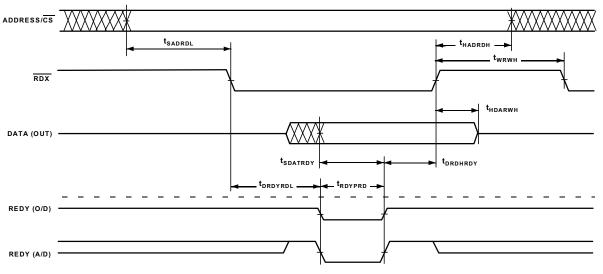
Use these specifications (Table 14 and Table 15) for asynchronous host processor accesses of an ADSP-21160M, after the host has asserted \overline{CS} and \overline{HBR} (low). After \overline{HBG}

is returned by the ADSP-21160M, the host can drive the $\overline{\text{RDx}}$ and $\overline{\text{WRx}}$ pins to access the ADSP-21160M's internal memory or IOP registers. HBR and HBG are assumed low for this timing

Table 14. Read Cycle

Parameter		Min	Max	Unit
Timing Requ	uirements:			
t _{sadrdl}	Address Setup/CS Low Before RDx Low	0		ns
t _{HADRDH}	Address Hold/CS Hold Low After RDx	2		ns
t _{wrwH}	RDx/WRx High Width	5		ns
t _{DRDHRDY}	RDx High Delay After REDY (O/D) Disable	0		ns
t _{DRDHRDY}	RDx High Delay After REDY (A/D) Disable	0		ns
Switching Cl	haracteristics:			
t _{sdatrdy}	Data Valid Before REDY Disable from Low	2		ns
t _{DRDYRDL}	REDY (O/D) or (A/D) Low Delay After RDx Low		10	ns
t _{rdyprd}	REDY (O/D) or (A/D) Low Pulsewidth for Read	t _{CK}		ns
t _{HDARWH}	Data Disable After RDx High	2	6	ns





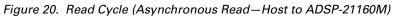
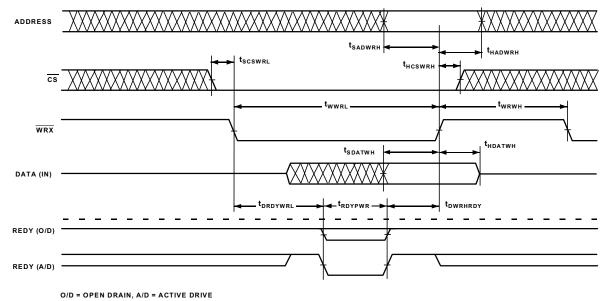
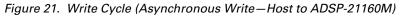


Table 15. Write Cycle

Parameter		Min	Max	Unit
Timing Requ	uirements:			
t _{SCSWRL}	CS Low Setup Before WRx Low	0		ns
t _{HCSWRH}	CS Low Hold After WRx High	0		ns
t _{sadwrh}	Address Setup Before WRx High	6		ns
t _{HADWRH}	Address Hold After WRx High	2		ns
t _{wwrL}	WRx Low Width	7		ns
t _{wrwh}	RDx/WRx High Width	5		ns
t _{DWRHRDY}	WRx High Delay After REDY (O/D) or (A/D) Disable	0		ns
t _{sdatwh}	Data Setup Before WRx High	5		ns
t _{HDATWH}	Data Hold After WRx High	4		ns
Switching C	haracteristics:			
t _{DRDYWRL}	REDY (O/D) or (A/D) Low Delay After WRx/CS Low		11	ns
t _{RDYPWR}	REDY (O/D) or (A/D) Low Pulsewidth for Write	12		ns

WRITE CYCLE





Three-State Timing—Bus Master and Bus Slave

These specifications show how the memory interface is disabled (stops driving) or enabled (resumes driving) relative to CLKIN and the $\overline{\text{SBTS}}$ pin. This timing is applicable to bus master transition cycles (BTC) and host transition cycles (HTC) as well as the $\overline{\text{SBTS}}$ pin.

Table 16. Three-State Timing-Bus Slave, HBR, SBTS

Parameter		Min	Max	Unit
Timing Requ	uirements:			
t _{stsck}	SBTS Setup Before CLKIN	6		ns
t _{HTSCK}	SBTS Hold After CLKIN	1		ns
Switching C	Characteristics:			
t _{MIENA}	Address/Select Enable After CLKIN	1.5	9	ns
t _{MIENS}	Strobes Enable After CLKIN ¹	1.5	9	ns
t _{MIENHG}	HBG Enable After CLKIN	1.5	9	ns
t _{MITRA}	Address/Select Disable After CLKIN	$0.25t_{\text{CCLK}}-1$	$0.25t_{\text{CCLK}}+4$	ns
t _{MITRS}	Strobes Disable After CLKIN ¹	$0.25t_{\text{CCLK}}-4$	$0.25t_{\text{CCLK}}$	ns
t _{MITRHG}	HBG Disable After CLKIN	3.5	8	ns
t _{DATEN}	Data Enable After CLKIN ²	1.5	10	ns
t _{DATTR}	Data Disable After CLKIN ²	1.5	5	ns
t _{ACKEN}	ACK Enable After CLKIN ²	1.5	9	ns
t _{ACKTR}	ACK Disable After CLKIN ²	1.5	5	ns
t _{CDCEN}	CLKOUT Enable After CLKIN	1.5	9	ns
t _{cdctr}	CLKOUT Disable After CLKIN	$t_{\rm CCLK} - 3$	t_{CCLK} +1	ns
t _{MTRHBG}	Memory Interface Disable Before HBG	t _{CK} -6	t _{CK} +2	ns
	Low ³			
t _{MENHBG}	Memory Interface Enable After HBG	t _{ck} -5	t _{ск} +5	ns
	High ³			

¹Strobes = \overline{RDx} , \overline{WRx} , \overline{DMAGx} .

²In addition to bus master transition cycles, these specs also apply to bus master and bus slave synchronous read/write.

³Memory Interface = Address, $\overline{\text{RDx}}$, $\overline{\text{WRx}}$, $\overline{\text{MSx}}$, PAGE, $\overline{\text{DMAGx}}$, and $\overline{\text{BMS}}$ (in EPROM boot mode).

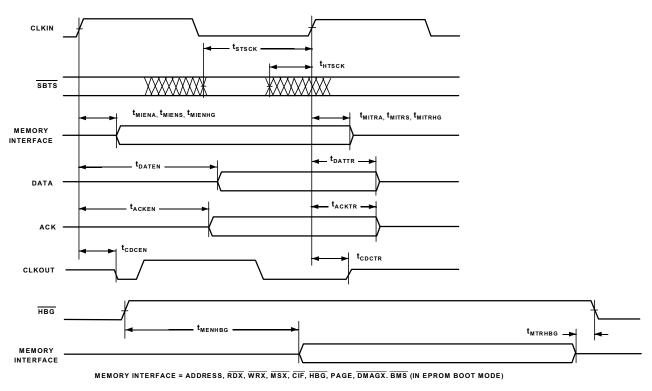


Figure 22. Three-State Timing–Bus Slave, HBR, SBTS

DMA Handshake

These specifications describe the three DMA handshake modes. In all three modes $\overline{\text{DMAR}}$ is used to initiate transfers. For handshake mode, $\overline{\text{DMAG}}$ controls the latching or enabling of data externally. For external handshake mode, the data transfer is controlled by the ADDR31–0, $\overline{\text{RDx}}$, $\overline{\text{WRx}}$, PAGE, $\overline{\text{MS3-0}}$, ACK, and $\overline{\text{DMAG}}$ signals. For Paced

Master mode, the data transfer is controlled by ADDR31–0, RDx, WRx, MS3–0, and ACK (not DMAG). For Paced Master mode, the Memory Read-Bus Master, Memory Write-Bus Master, and Synchronous Read/Write-Bus Master timing specifications for ADDR31–0, RDx, WRx, MS3–0, PAGE, DATA63–0, and ACK also apply.

Table 17. DMA Handshake

Parameter		Min	Max	Unit
Timing Requir	ements:			
t _{SDRC}	DMARx Setup Before CLKIN ¹	3		ns
t _{wDR}	$\overline{\text{DMARx}}$ Width Low (Nonsynchronous) ²	t_{CCLK} +4.5		ns
t _{sDATDGL}	Data Setup After DMAGx Low ³		$0.75t_{CK} - 7$	ns
t _{hDATIDG}	Data Hold After DMAGx High	2		ns
t _{DATDRH}	Data Valid After DMARx High ³		t _{ck} +10	ns
t _{DMARLL}	DMARx Low Edge to Low Edge ⁴	t _{ck}		ns
t _{DMARH}	DMARx Width High ²	t_{CCLK} +4.5		ns
Switching Cha	racteristics:			
t _{DDGL}	DMAGx Low Delay After CLKIN	$0.25t_{CCLK} + 1$	$0.25t_{CCLK} + 9$	ns
t _{wDGH}	DMAGx High Width	$0.5t_{\text{CCLK}} - 1 + \text{HI}$		ns
t _{WDGL}	DMAGx Low Width	$t_{ck} = 0.5t_{cclk} = 1$		ns
t _{HDGC}	DMAGx High Delay After CLKIN	$t_{CK} - 0.25t_{CCLK} + 1.5$	$t_{CK} = 0.25 t_{CCLK} + 9$	ns
t _{vDATDGH}	Data Valid Before DMAGx High ⁵	$t_{ck} - 0.25 t_{cclk} - 8$	$t_{CK} - 0.25 t_{CCLK} + 5$	ns
t _{DATRDGH}	Data Disable After DMAGx High ⁶	$0.25t_{\text{CCLK}}-3$	$0.25t_{CCLK} + 1.5$	ns
t _{DGWRL}	WRx Low Before DMAGx Low	-1.5	2	ns
t _{DGWRH}	DMAGx Low Before WRx High	$t_{ck} - 0.5 t_{cclk} - 2 + W$		ns
t _{DGWRR}	WRx High Before DMAGx High ⁷	-1.5	2	ns
t _{DGRDL}	RDx Low Before DMAGx Low	-1.5	2	ns
t _{DRDGH}	RDx Low Before DMAGx High	$t_{ck} - 0.5 t_{cclk} - 2 + W$		ns
t _{DGRDR}	RDx High Before DMAGx High ⁷	-1.5	2	ns
t _{DGWR}	DMAGx High to WRx, RDx, DMAGx	$0.5t_{\text{CCLK}}-2+\text{HI}$		ns
	Low			
t _{DADGH}	Address/Select Valid to DMAGx High	18		ns
t _{DDGHA}	Address/Select Hold after DMAGx High	1		ns
W = (number	of wait states specified in WAIT register) \times t _c	К•		•

 $HI = t_{CK}$ (if data bus idle cycle occurs, as specified in WAIT register; otherwise HI = 0).

¹Only required for recognition in the current cycle.

²Maximum throughput using $\overline{\text{DMARx}/\text{DMAGx}}$ handshaking equals $t_{WDR} + t_{DMARH} = (t_{CCLK} + 4.5) + (t_{CCLK} + 4.5) = 34$ ns (29.4 MHz). This throughput limit applies to non-synchronous access mode only.

 $^{3}t_{\text{SDATDGL}}$ is the data setup requirement if $\overline{\text{DMARx}}$ is not being used to hold off completion of a write. Otherwise, if $\overline{\text{DMARx}}$ low holds off completion of the write, the data can be driven t_{DATDRH} after $\overline{\text{DMARx}}$ is brought high.

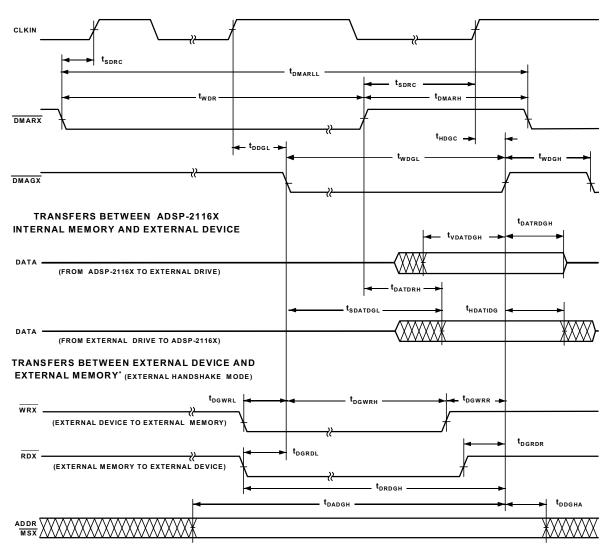
⁴Use t_{DMARLL} if DMARx transitions synchronous with CLKIN. Otherwise, use t_{WDR} and t_{DMARH}.

 ${}^{5}t_{VDATDGH}$ is valid if \overline{DMARx} is not being used to hold off completion of a read. If \overline{DMARx} is used to prolong the read, then

 $t_{VDATDGH} = t_{CK} - .25t_{CCLK} - 8 + (n \times t_{CK})$ where n equals the number of extra cycles that the access is prolonged.

⁶See Example System Hold Time Calculation on page 44 for calculation of hold times given capacitive and dc loads.

⁷This parameter applies for synchronous access mode only.



* MEMORY READ BUS MASTER, MEMORY WRITE BUS MASTER, OR SYNCHRONOUS READ/WRITE BUS MASTER TIMING SPECIFICATIONS FOR ADDR31-0, RDx, WRx, MS3-0 AND ACK ALSO APPLY HERE.

Figure 23. DMA Handshake Timing

Link Ports

Calculation of link receiver data setup and hold relative to link clock is required to determine the maximum allowable skew that can be introduced in the transmission path between LDATA and LCLK. Setup skew is the maximum delay that can be introduced in LDATA relative to LCLK (setup skew = $t_{LCLKTWH}$ Min – t_{DLDCH} – t_{SLDCL}). Hold skew is the maximum delay that can be introduced in LCLK relative to LDATA (hold skew = $t_{LCLKTWL}$ Min – t_{HLDCH} – t_{HLDCL}). Calculations made directly from speed specifications will result in unrealistically small skew times because they include multiple tester guardbands.

Note that there is a two-cycle effect latency between the link port enable instruction and the DSP enabling the link port.

Maximum throughput varies across link port transmit/receive pairs. Table 18 shows maximum throughput for all transmit/receive pairs based on setup skew of 0.5 ns (setup skew= $t_{LCLKTWH}$ min- t_{DLDCH} - t_{SLDCL} =0.5 ns). Hold skew results indicate 80 MHz operation across all link ports. All hold time skews are equal to 0.5 ns or greater for all link port transmit/receive pairs at 80 MHz. Based upon these values, all link port transmit/receive pairs can be operated at maximum throughput for LxCLK:CCLK ratios of 2:1, 3:1, and 4:1 at 80 MHz CCLK. To operate all link port transmit/receive pairs at LxCLK:CCLK ratio of 1:1, the core clock frequency must be no greater than 62.5 MHz.

Maximum data throughput values are based upon the reset value of the LAR Link Port Assignment Register (Link Buffer 0 assigned to Link Port 0, Link Buffer 1 assigned to Link Port 1, etc.). Throughputs are not guaranteed for LAR settings other than the reset LAR value. For additional details on LAR, refer to the *ADSP-21160 DSP Hardware Reference* manual.

Table 18. Link Port—Maximum Data Throughput forTransmit/Receive Pairs

Transmit Link Port	Receive Link Port	Maximum Operating Frequency (MHz)
0	0	71.43
	1	74.07
	2	71.43
	3	80
	4	80
	5	76.92
1	0	68.97
	1	71.43
	2	68.97
	3	80
	4	76.92
	5	74.07

Table 18.	Link Port—Max	ximum Dat	a Throughput for
Transmit	Receive Pairs ((Continued)	

Transmit	Receive	Maximum Operating
Link Port	Link Port	Frequency (MHz)
2	0	68.97
	1	71.43
	2	71.43
	3	80
	4	76.92
	5	74.07
3	0	64.52
	1	66.67
	2	66.67
	2 3	71.43
	4	71.43
	5	71.43
4	0	64.52
	1	66.67
	2	66.67
	3	74.07
	4	74.07
	5	71.43
5	0	62.5
	1	66.67
	2	64.52
	3	71.43
	4	71.43
	5	71.43

Table 19. Link Ports-Receive

Parameter		Min	Max	Unit
Timing Requ	urements:			
t _{SLDCL}	Data Setup Before LCLK Low	2.5		ns
t _{HLDCL}	Data Hold After LCLK Low	2.5		ns
t _{LCLKIW}	LCLK Period	t_{LCLK}		ns
t _{LCLKRWL}	LCLK Width Low	6.0		ns
t _{LCLKRWH}	LCLK Width High	6.0		ns
	haracteristics:			
t _{DLALC}	LACK Low Delay After LCLK High ¹	12	17	ns

 $^{1}LACK$ goes low with t_{DLALC} relative to rise of LCLK after first nibble, but doesn't go low if the receiver's link buffer is not about to fill.

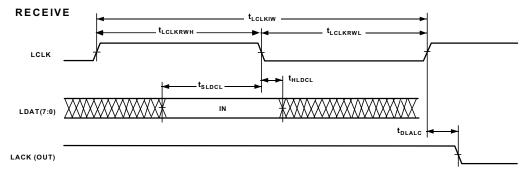
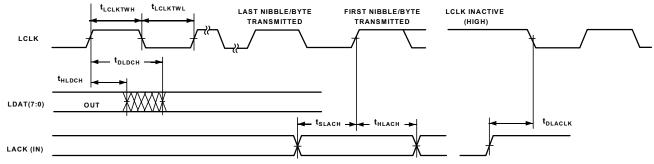


Figure 24. Link Ports-Receive

Table 20. Link Ports-Transmit

Parameter		Min	Max	Unit
Timing Requ	uirements:			
t _{SLACH}	LACK Setup Before LCLK High	14		ns
t _{HLACH}	LACK Hold After LCLK High	-2		ns
Switching C	haracteristics:			
t _{DLDCH}	Data Delay After LCLK High		6.0	ns
t _{HLDCH}	Data Hold After LCLK High	-2		ns
t _{lCLKTWL}	LCLK Width Low	$0.5t_{\rm LCLK} - 1.5$	$0.5t_{LCLK} + 1.5$	ns
t _{lCLKTWH}	LCLK Width High	$0.5t_{LCLK} - 1.5$	$0.5t_{LCLK} + 1.5$	ns
t _{DLACLK}	LCLK Low Delay After LACK High	$0.5t_{LCLK}+5$	$3t_{LCLK}+11$	ns

TRANSMIT



The t_{slach} requirement applies to the rising edge of LCLK only for the first nibble transmitted.

Figure 25. Link Ports-Transmit

Serial Ports

To determine whether communication is possible between two devices at clock speed n, the following specifications must be confirmed: 1) frame sync delay and frame sync setup and hold, 2) data delay and data setup and hold, and 3) SCLK width.

Table 21. Serial Ports-External Clock

Parameter		Min	Unit	
Timing Req	nuirements:			
t _{SFSE}	TFS/RFS Setup Before TCLK/RCLK ¹	3.5		ns
t _{HFSE}	TFS/RFS Hold After TCLK/RCLK ^{1,2}	4		ns
t _{sdre}	Receive Data Setup Before RCLK ¹	1.5		ns
t _{HDRE}	Receive Data Hold After RCLK ¹	4		ns
t _{sclkw}	TCLK/RCLK Width	14		ns
t _{SCLK}	TCLK/RCLK Period	$2t_{\text{CCLK}}$		ns

¹Referenced to sample edge.

²RFS hold after RCK when MCE = 1, MFD = 0 is 0 ns minimum from drive edge. TFS hold after TCK for late external TFS is 0 ns minimum from drive edge.

Table 22. Serial Ports—Internal Clock

Parameter	c	Min	Max	Unit
Timing Req	nuirements:			
t _{sFSI}	TFS Setup Before TCLK ¹ ; RFS Setup Before RCLK ¹	8		ns
t _{HFSI}	TFS/RFS Hold After TCLK/RCLK ^{1,2}	1		ns
t _{sdri}	Receive Data Setup Before RCLK ¹	6.5		ns
t _{HDRI}	Receive Data Hold After RCLK ¹	3		ns

¹Referenced to sample edge.

 2 RFS hold after RCK when MCE = 1, MFD = 0 is 0 ns minimum from drive edge. TFS hold after TCK for late external TFS is 0 ns minimum from drive edge.

Table 23. Serial Ports-External or Internal Clock

Parameter		Min	Max	Unit
Switching C	haracteristics:			
t _{DFSE}	RFS Delay After RCLK (Internally Generated RFS) ¹		13	ns
t _{HOFSE}	RFS Hold After RCLK (Internally Generated RFS) ¹	3		ns

¹Referenced to drive edge.

Table 24. Serial Ports-External Clock

Parameter		Min	Max	Unit
Switching C	Characteristics:			
t _{DFSE}	TFS Delay After TCLK (Internally Generated TFS) ¹		13	ns
t _{HOFSE}	TFS Hold After TCLK (Internally Generated TFS) ¹	3		ns
t_{DDTE}	Transmit Data Delay After TCLK ¹		16	ns
t _{HDTE}	Transmit Data Hold After TCLK ¹	0		ns

¹Referenced to drive edge.

Table 25. Serial Ports—Internal Clock

Parameter	r	Min	Max	Unit
Switching (Characteristics:			
t _{DFSI}	TFS Delay After TCLK (Internally Generated TFS) ¹		4.5	ns
t _{HOFSI}	TFS Hold After TCLK (Internally Generated TFS) ¹	-1.5		ns

Table 25. Serial Ports—Internal Clock (Continued)

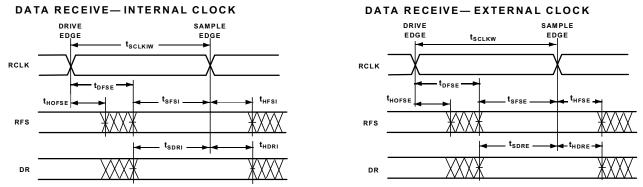
Parameter		Min	Max	Unit
t _{DDTI}	Transmit Data Delay After TCLK ¹		7.5	ns
t _{HDTI}	Transmit Data Hold After TCLK ¹	0		ns
t _{sclkiw}	TCLK/RCLK Width	$0.5t_{\text{SCLK}} - 2.5$	$0.5t_{SCLK}+2$	ns

¹Referenced to drive edge.

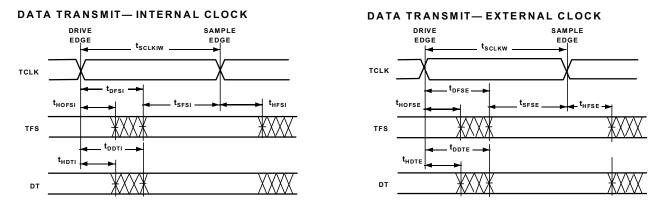
Table 26. Serial Ports-Enable and Three-State

Parameter		Min	Max	Unit
Switching C	Characteristics:			
t _{DDTEN}	Data Enable from External TCLK ¹	4		ns
t _{DDTTE}	Data Disable from External TCLK ¹		10	ns
t _{DDTIN}	Data Enable from Internal TCLK ¹	0		ns
t _{DDTTI}	Data Disable from Internal TCLK ¹		3	ns

¹Referenced to drive edge.



NOTE: EITHER THE RISING EDGE OR FALLING EDGE OF RCLK, TCLK CAN BE USED AS THE ACTIVE SAMPLING EDGE.



NOTE: EITHER THE RISING EDGE OR FALLING EDGE OF RCLK, TCLK CAN BE USED AS THE ACTIVE SAMPLING EDGE.

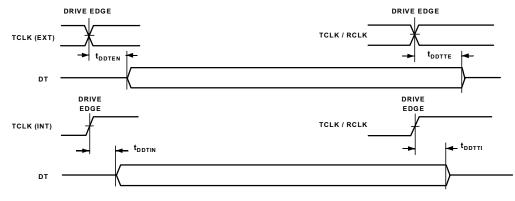
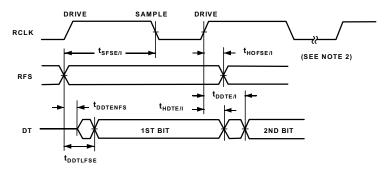


Figure 26. Serial Ports

Table 27. Serial Ports—External Late Frame Sync

Parameter		Min	Max	Unit
Switching C	haracteristics:			
t _{DDTLFSE}	Data Delay from Late External TFS or External RFS with MCE = 1, MFD = 0^1		13	ns
t _{DDTENFS}	Data Enable from late FS or MCE = 1, MFD = 0^1	1.0		ns

 $^{1}MCE = 1$, TFS enable and TFS valid follow $t_{DDTLFSE}$ and $t_{DDTENFS}$.



EXTERNAL RFS WITH MCE = 1, MFD = 0

LATE EXTERNAL TFS

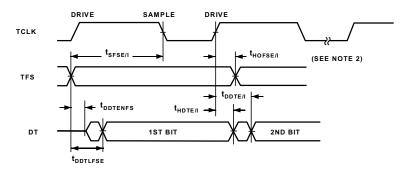


Figure 27. External Late Frame Sync

JTAG Test Access Port and Emulation

Table 28. JTAG Test Access Port and Emulation

Parameter	r	Min	Unit	
Timing Rea	quirements:			
t _{TCK}	TCK Period	t _{CK}		ns
t _{stap}	TDI, TMS Setup Before TCK High	5		ns
t _{HTAP}	TDI, TMS Hold After TCK High	6		ns
t _{ssys}	System Inputs Setup Before TCK Low ¹	7		ns
t _{HSYS}	System Inputs Hold After TCK Low ¹	18		ns
t _{TRSTW}	TRST Pulsewidth	$4t_{CK}$		ns
Switching (Characteristics:			
t _{DTDO}	TDO Delay from TCK Low		13	ns
t _{DSYS}	System Outputs Delay After TCK Low ²		30	ns

¹System Inputs = DATA63–0, ADDR31–0, RDx, WRx, ACK, SBTS, HBR, HBG, CS, DMARI, DMAR2, BR6–1, ID2–0, RPBA, IRQ2–0, FLAG3–0, PA, BRST, DR0, DR1, TCLK0, TCLK1, RCLK0, RCLK1, TFS0, TFS1, RFS0, RFS1, LxDAT7–0, LxCLK, LxACK, EBOOT, LBOOT, BMS, CLKIN, RESET.

²System Outputs = DATA63-0, ADDR31-0, <u>MS3-0</u>, <u>RDx</u>, <u>WRx</u>, ACK, PAGE, CLKOUT, <u>HBG</u>, REDY, <u>DMAG1</u>, <u>DMAG2</u>, <u>BR6-1</u>, <u>PA</u>, <u>BRST</u>, <u>CIF</u>, FLAG3-0, TIMEXP, DT0, DT1, TCLK0, TCLK1, RCLK0, RCLK1, TFS0, TFS1, RFS0, RFS1, LxDAT7-0, LxCLK, LxACK, <u>BMS</u>.

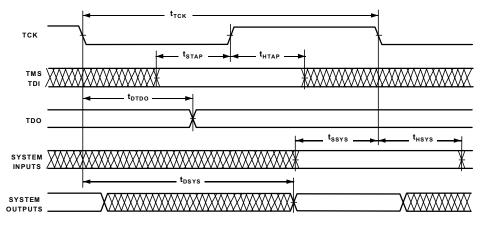


Figure 28. IEEE 11499.1 JTAG Test Access Port

Output Drive Currents

Figure 29 shows typical I–V characteristics for the output drivers of the ADSP-21160M. The curves represent the current drive capability of the output drivers as a function of output voltage.

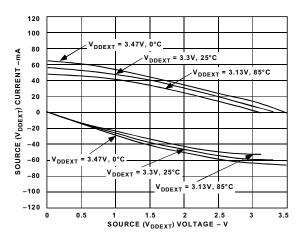


Figure 29. ADSP-21160M Typical Drive Currents

Power Dissipation

Total power dissipation has two components, one due to internal circuitry and one due to the switching of external output drivers.

Internal power dissipation is dependent on the instruction execution sequence and the data operands involved. Using the current specifications ($I_{DDINFEAK}$, $I_{DDINHIGH}$, $I_{DDINLOW}$, I_{DDIDLE}) from Electrical Characteristics on page 13 and the current-versus-operation information in Table 29, engineers can estimate the ADSP-21160M's internal power supply (V_{DDINT}) input current for a specific application, according to the following formula:

$$\label{eq:peak_linear_prod} \begin{split} &\% \, \text{Peak} \times I_{DDINPEAK} \\ &\% \, \text{High} \times I_{DDINHIGH} \\ &\% \, \text{Low} \times I_{DDINLOW} \\ & \frac{+ \,\% \, \text{Idle} \times I_{DDIDLE}}{I_{DDINT}} \end{split}$$

The external component of total power dissipation is caused by the switching of output pins. Its magnitude depends on:

- the number of output pins that switch during each cycle (O)
- the maximum frequency at which they can switch (f)
- their load capacitance (C)
- their voltage swing (VDD)

and is calculated by:

$$P_{\rm EXT} = O \times C \times V_{\rm DD}^2 \times f$$

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The load capacitance should include the processor's package capacitance (C_{IN}) . The switching frequency includes driving the load high and then back low. Address and data pins can drive high and low at a maximum rate of

 $1/(2t_{\mbox{\tiny CK}}).$ The write strobe can switch every cycle at a frequency of $1/t_{\mbox{\tiny CK}}.$ Select pins switch at $1/(2t_{\mbox{\tiny CK}})$, but selects can switch on each cycle.

Table 29. ADSP-	-21160M Operation	n Types vs. Input Current
-----------------	-------------------	---------------------------

Operation	Peak Activity ¹	High Activity ¹	Low Activity ¹
Instruction Type	Multifunction	Multifunction	Single Function
Instruction Fetch	Cache	Internal Memory	Internal Memory
Core Memory Access ²	2 per t_{CK} cycle (DM×64 and PM×64)	1 per t_{CK} cycle (DM×64)	None
Internal Memory DMA	1 per 2 t _{CCLK} cycles	1 per 2 t _{CCLK} cycles	None
External Memory DMA	1 per external port cycle (×64)	1 per external port cycle (×64)	None
Data bit pattern for core	Worst case	Random	N/A
memory access and DMA			

 1 Peak Activity= $I_{DDINPEAK}$, High Activity= $I_{DDINHIGH}$, and Low Activity= $I_{DDINLOW}$. The state of the PEYEN bit (SIMD versus SISD mode) does not influence these calculations.

²These assume a 2:1 core clock ratio. For more information on ratios and clocks (t_{CK} and t_{CCLK}), see the timing ratio definitions on page 15.

Example: Estimate P_{EXT} with the following assumptions:

- A system with one bank of external data memory—asynchronous RAM (64-bit)
- Four 64K × 16 RAM chips are used, each with a load of 10 pF

Pin Type	# of Pins	% Switching	× C	×f	× VDD^2	$= \mathbf{P}_{\text{EXT}}$
Address	15	50	× 44.7 pF	× 12.5 MHz	× 10.9 V	= 0.046 W
MS0	1	0	× 44.7 pF	× 12.5 MHz	× 10.9 V	= 0.000 W
WRx	2	-	× 44.7 pF	× 25 MHz	× 10.9 V	= 0.024 W
Data	64	50	× 14.7 pF	× 12.5 MHz	× 10.9 V	= 0.064 W
CLKOUT	1	-	× 4.7 pF	× 25 MHz	× 10.9 V	= 0.001 W
	÷	·	·		•	$P_{EXT} = 0.135 W$

Table 30.	External	Power	Calculations	(3.3	V Device)
-----------	----------	-------	--------------	------	-----------

- External data memory writes occur every other cycle, a rate of $1/(4 t_{CK})$, with 50% of the pins switching
- The bus cycle time is 40 MHz (t_{CK} = 25 ns).

The $P_{\mbox{\tiny EXT}}$ equation is calculated for each class of pins that can drive:

A typical power consumption can now be calculated for these conditions by adding a typical internal power dissipation:

$$P_{\text{TOTAL}} = P_{\text{EXT}} + P_{\text{INT}} + P_{\text{PLI}}$$

Where:

- *P*_{EXT} is from Table 30
- P_{INT} is $I_{\text{DDINT}} \times 2.5$ V, using the calculation I_{DDINT} listed in Power Dissipation on page 42
- P_{PIL} is AI_{DD} × 2.5V, using the value for AI_{DD} listed in ABSOLUTE MAXIMUM RATINGS on page 14

Note that the conditions causing a worst-case P_{EXT} are different from those causing a worst-case P_{INT} . Maximum P_{INT} cannot occur while 100% of the output pins are switching from all ones to all zeros. Note also that it is not common for an application to have 100% or even 50% of the outputs switching simultaneously.

Test Conditions

The test conditions for timing parameters appearing in ADSP-21160M specifications on page 13 include output disable time, output enable time, and capacitive loading.

Output Disable Time

Output pins are considered to be disabled when they stop driving, go into a high impedance state, and start to decay from their output high or low voltage. The time for the voltage on the bus to decay by -V is dependent on the capacitive load, C_L and the load current, I_L . This decay time can be approximated by the following equation:

$$E_{\rm DECAY} = (C_{\rm L}\Delta V)/I_{\rm L}$$

The output disable time t_{DIS} is the difference between $t_{MEASURED}$ and t_{DECAY} as shown in Figure 30. The time $t_{MEASURED}$ is the interval from when the reference signal switches to when the output voltage decays -V from the measured output high or output low voltage. t_{DECAY} is calculated with test loads C_L and I_L , and with -V equal to 0.5 V.

Output Enable Time

Output pins are considered to be enabled when they have made a transition from a high impedance state to when they start driving. The output enable time t_{ENA} is the interval from when a reference signal reaches a high or low voltage level to when the output has reached a specified high or low trip point, as shown in the Output Enable/Disable diagram (Figure 30). If multiple pins (such as the data bus) are enabled, the measurement value is that of the first pin to start driving.

Example System Hold Time Calculation

To determine the data output hold time in a particular system, first calculate t_{DECAY} using the equation given above. Choose –V to be the difference between the ADSP-21160M's output voltage and the input threshold for the device requiring the hold time. A typical –V will be 0.4 V. C_L is the total bus capacitance (per data line), and I_L is the total leakage or three-state current (per data line). The hold time will be t_{DECAY} plus the minimum disable time (i.e., t_{DATRWH} for the write cycle).

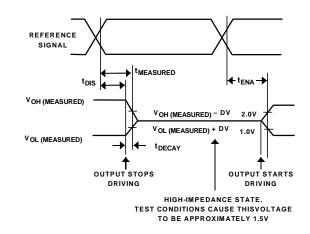


Figure 30. Output Enable/Disable

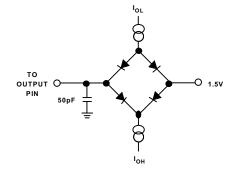


Figure 31. Equivalent Device Loading for AC Measurements (Includes All Fixtures)



Figure 32. Voltage Reference Levels for AC Measurements (Except Output Enable/Disable)

Capacitive Loading

Output delays and holds are based on standard capacitive loads: 50 pF on all pins (see Figure 31). The delay and hold specifications given should be derated by a factor of 1.5 ns/50 pF for loads other than the nominal value of 50 pF. Figure 33 and Figure 34 show how output rise time varies with capacitance. Figure 35 graphically shows how output delays and holds vary with load capacitance. (Note that this graph or derating does not apply to output disable delays; see Output Disable Time on page 44.) The graphs of Figure 33, Figure 34, and Figure 35 may not be linear outside the ranges shown.

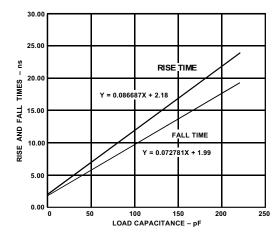


Figure 33. Typical Output Rise Time (10%–90%, $V_{DDEXT} = Max$) vs. Load Capacitance

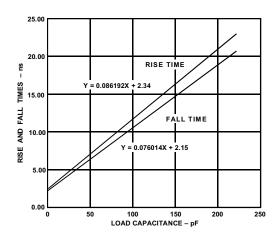


Figure 34. Typical Output Rise Time (10%–90%, $V_{DDEXT} = Min$) vs. Load Capacitance

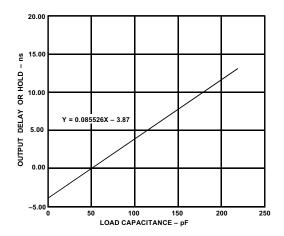


Figure 35. Typical Output Delay or Hold vs. Load Capacitance (at Max Case Temperature)

Environmental Conditions

The ADSP-21160M is tested for performance over the commercial temperature range, 0°C to 85°C.

Thermal Characteristics

The ADSP-21160M is packaged in a 400-ball Plastic Ball Grid Array (PBGA). The ADSP-21160M is specified for a case temperature (T_{CASE}). To ensure that the T_{CASE} data sheet specification is not exceeded, a heatsink and/or an air flow source may be used. Use the center block of ground pins (PBGA balls: H8–13, J8–13, K8–13, L8–13, M8–13, and N8–13) to provide thermal pathways to the printed circuit board's ground plane. A heatsink should be attached to the ground plane (as close as possible to the thermal pathways) with a thermal adhesive.

 $T_{CASE} = T_{AMB} + (PD \times \theta_{CA})$

- T_{CASE} = Case temperature (measured on top surface of package)
- *PD* = Power dissipation in W (this value depends upon the specific application; a method for calculating PD is shown under Power Dissipation).
- θ_{CA} = Value from Table 31.
- $\theta_{JB} = 6.46^{\circ} C/W$

Table 31. Airflow Over Package Versus $\theta_{\scriptscriptstyle CA}$

Airflow (Linear Ft./Min.)	0	200	400
θ_{CA} (°C/W) ¹	12.13	9.86	8.7
$^{1}\theta_{\rm JC} = 3.6 ^{\circ}{\rm C/W}.$			

400-BALL METRIC PBGA PIN CONFIGURATIONS Table 32 lists the pin assignments for the PBGA package, and the pin configurations diagram on page 51 shows the pin assignment summary.

Pin Name	PBGA Pin#						
DATA[14]	A01	DATA[22]	B01	DATA[24]	C01	DATA[28]	D01
DATA[13]	A02	DATA[16]	B02	DATA[18]	C02	DATA[25]	D02
DATA[10]	A03	DATA[15]	B03	DATA[17]	C03	DATA[20]	D03
DATA[8]	A04	DATA[9]	B04	DATA[11]	C04	DATA[19]	D04
DATA[4]	A05	DATA[6]	B05	DATA[7]	C05	DATA[12]	D05
DATA[2]	A06	DATA[3]	B06	DATA[5]	C06	V _{DDEXT}	D06
TDI	A07	DATA[0]	B07	DATA[1]	C07	V _{DDINT}	D07
TRST	A08	TCK	B08	TMS	C08	V _{DDEXT}	D08
RESET	A09	EMU	B09	TD0	C09	V_{DDEXT}	D09
RPBA	A10	IRQ2	B10	IRQ1	C10	V _{DDEXT}	D10
IRQ 0	A11	FLAG3	B11	FLAG2	C11	V _{DDEXT}	D11
FLAG1	A12	FLAG0	B12	V _{DDEXT}	C12	V _{DDEXT}	D12
TIMEXP	A13	V _{DDEXT}	B13	NC	C13	V _{DDINT}	D13
V_{DDEXT}	A14	NC	B14	TCLK1	C14	V _{DDEXT}	D14
NC	A15	DT1	B15	DR1	C15	TFS0	D15
TFS1	A16	RCLK1	B16	DR0	C16	L1DAT[7]	D16
RFS1	A17	RFS0	B17	L0DAT[7]	C17	L0CLK	D17
RCLK0	A18	TCLK0	B18	L0DAT[6]	C18	L0DAT[3]	D18
DT0	A19	L0DAT[5]	B19	LOACK	C19	L0DAT[1]	D19
L0DAT[4]	A20	L0DAT[2]	B20	L0DAT[0]	C20	L1CLK	D20
DATA[30]	E01	DATA[34]	F01	DATA[38]	G01	DATA[40]	H01
DATA[29]	E02	DATA[33]	F02	DATA[35]	G02	DATA[39]	H02
DATA[23]	E03	DATA[27]	F03	DATA[32]	G03	DATA[37]	H03
DATA[21]	E04	DATA[26]	F04	DATA[31]	G04	DATA[36]	H04
V_{DDEXT}	E05	V _{DDEXT}	F05	V _{DDEXT}	G05	V _{DDEXT}	H05
V_{DDINT}	E06	V _{DDINT}	F06	V _{DDINT}	G06	V _{DDINT}	H06
V_{DDINT}	E07	GND	F07	GND	G07	GND	H07
V_{DDINT}	E08	GND	F08	GND	G08	GND	H08
V_{DDINT}	E09	GND	F09	GND	G09	GND	H09
V_{DDINT}	E10	GND	F10	GND	G10	GND	H10
GND	E11	GND	F11	GND	G11	GND	H11
V_{DDINT}	E12	GND	F12	GND	G12	GND	H12
V_{DDINT}	E13	GND	F13	GND	G13	GND	H13
V_{DDINT}	E14	GND	F14	GND	G14	GND	H14
V_{DDINT}	E15	V _{DDINT}	F15	V _{DDINT}	G15	V _{DDINT}	H15
V_{DDEXT}	E16	V _{DDEXT}	F16	V _{DDEXT}	G16	V _{DDEXT}	H16
L1DAT[6]	E17	L1DAT[4]	F17	L1DAT[2]	G17	L2DAT[5]	H17
L1DAT[5]	E18	L1DAT[3]	F18	L2DAT[6]	G18	L2ACK	H18
L1ACK	E19	L1DAT[0]	F19	L2DAT[4]	G19	L2DAT[3]	H19
L1DAT[1]	E20	L2DAT[7]	F20	L2CLK	G20	L2DAT[1]	H20

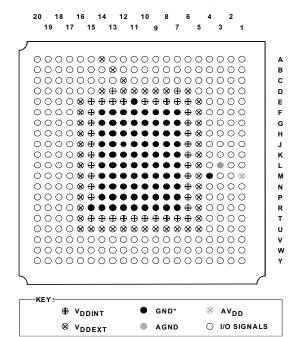
Table 32. 400-ball Metric PBGA Pin Assignments

Pin Name	PBGA Pin#						
DATA[44]	J01	CLK_CFG_0	K01	CLKIN	L01	AV_{DD}	M01
DATA[43]	J02	DATA[46]	K02	CLK_CFG_1	L02	CLK_CFG_3	M02
DATA[42]	J03	DATA[45]	K03	AGND	L03	CLKOUT	M03
DATA[41]	J04	DATA[47]	K04	CLK_CFG_2	L04	GND	M04
V _{DDEXT}	J05	V _{DDEXT}	K05	V _{DDEXT}	L05	V _{DDEXT}	M05
V _{DDINT}	J06	V _{DDINT}	K06	V _{DDINT}	L06	V _{DDINT}	M06
GND	J07	GND	K07	GND	L07	GND	M07
GND	J08	GND	K08	GND	L08	GND	M08
GND	J09	GND	K09	GND	L09	GND	M09
GND	J10	GND	K10	GND	L10	GND	M10
GND	J11	GND	K11	GND	L11	GND	M11
GND	J12	GND	K12	GND	L12	GND	M12
GND	J13	GND	K13	GND	L13	GND	M13
GND	J14	GND	K14	GND	L14	GND	M14
V _{DDINT}	J15	V _{DDINT}	K15	V _{DDINT}	L15	V _{DDINT}	M15
V _{DDEXT}	J16	V _{DDEXT}	K16	V _{DDEXT}	L16	V _{DDEXT}	M16
L2DAT[2]	J17	BR6	K17	BR2	L17	PAGE	M17
L2DAT[0]	J18	BR5	K18	BR1	L18	SBTS	M18
HBG	J19	BR4	K19	ACK	L19	PA	M19
HBR	J20	BR3	K20	REDY	L20	L3DAT[7]	M20
NC	N01	DATA[49]	P01	DATA[53]	R01	DATA[56]	T01
NC	N02	DATA[50]	P02	DATA[54]	R02	DATA[58]	T02
DATA[48]	N03	DATA[52]	P03	DATA[57]	R03	DATA[59]	T03
DATA[51]	N04	DATA[55]	P04	DATA[60]	R04	DATA[63]	T04
V _{DDEXT}	N05	V _{DDEXT}	P05	V _{DDEXT}	R05	V _{DDEXT}	T05
V _{DDINT}	N06	V _{DDINT}	P06	V _{DDINT}	R06	V _{DDINT}	T06
GND	N07	GND	P07	GND	R07	V _{DDINT}	T07
GND	N08	GND	P08	GND	R08	V _{DDINT}	T08
GND	N09	GND	P09	GND	R09	V _{DDINT}	T09
GND	N10	GND	P10	GND	R10	V _{DDINT}	T10
GND	N11	GND	P11	GND	R11	V _{DDINT}	T11
GND	N12	GND	P12	GND	R12	V _{DDINT}	T12
GND	N13	GND	P13	GND	R13	V _{DDINT}	T13
GND	N14	GND	P14	GND	R14	V _{DDINT}	T14
V _{DDINT}	N15	V _{DDINT}	P15	GND	R15	V _{DDINT}	T15
V _{DDEXT}	N16	V _{DDEXT}	P16	V _{DDEXT}	R16	V _{DDEXT}	T16
L3DAT[5]	N17	L3DAT[2]	P17	L4DAT[5]	R17	L4DAT[3]	T17
L3DAT[6]	N18	L3DAT[1]	P18	L4DAT[6]	R18	L4ACK	T18
L3DAT[4]	N19	L3DAT[3]	P19	L4DAT[7]	R19	L4CLK	T19
L3CLK	N20	L3ACK	P20	L3DAT[0]	R20	L4DAT[4]	T20

Table 32. 400-ball Metric PBGA Pin Assignments (Continued)

Pin Name	PBGA Pin#	Pin Name	PBGA Pin#	Pin Name	PBGA Pin#	Pin Name	PBGA Pin#
DATA[61]	U01	ADDR[4]	V01	ADDR[5]	W01	ADDR[8]	Y01
DATA[62]	U02	ADDR[6]	V02	ADDR[9]	W02	ADDR[11]	Y02
ADDR[3]	U03	ADDR[7]	V03	ADDR[12]	W03	ADDR[13]	Y03
ADDR[2]	U04	ADDR[10]	V04	ADDR[15]	W04	ADDR[16]	Y04
V_{DDEXT}	U05	ADDR[14]	V05	ADDR[17]	W05	ADDR[19]	Y05
V_{DDEXT}	U06	ADDR[18]	V06	ADDR[20]	W06	ADDR[21]	Y06
V_{DDEXT}	U07	ADDR[22]	V07	ADDR[23]	W07	ADDR[24]	Y07
V_{DDEXT}	U08	ADDR[25]	V08	ADDR[26]	W08	ADDR[27]	Y08
V_{DDEXT}	U09	ADDR[28]	V09	ADDR[29]	W09	ADDR[30]	Y09
V_{DDEXT}	U10	ID0	V10	ID1	W10	ADDR[31]	Y10
V_{DDEXT}	U11	ADDR[1]	V11	ADDR[0]	W11	ID2	Y11
V_{DDEXT}	U12	MS1	V12	BMS	W12	BRST	Y12
V_{DDEXT}	U13	CS	V13	MS2	W13	MS0	Y13
V_{DDEXT}	U14	RDL	V14	CIF	W14	MS3	Y14
V_{DDEXT}	U15	DMAR2	V15	RDH	W15	WRH	Y15
V_{DDEXT}	U16	L5DAT[0]	V16	DMAG2	W16	WRL	Y16
L5DAT[7]	U17	L5DAT[2]	V17	LBOOT	W17	DMAG1	Y17
L4DAT[0]	U18	L5ACK	V18	L5DAT[1]	W18	DMAR1	Y18
L4DAT[1]	U19	L5DAT[4]	V19	L5DAT[3]	W19	EBOOT	Y19
L4DAT[2]	U20	L5DAT[6]	V20	L5DAT[5]	W20	L5CLK	Y20

Table 32. 400-ball Metric PBGA Pin Assignments (Continued)



400-BALL METRIC PBGA PIN CONFIGURATIONS (BOTTOM VIEW, SUMMARY)

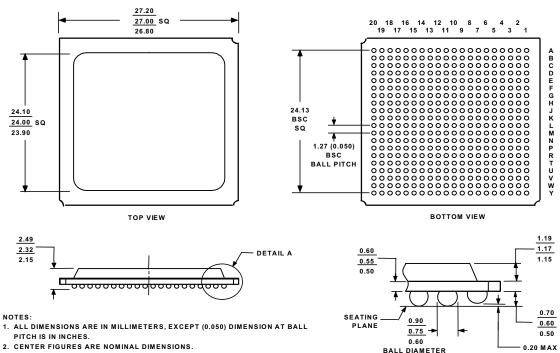
* USE THE CENTER BLOCK OF GROUND PINS (PBGA BALLS: H8-13, J8-13, K8-13, L8-13, M8-13, AND N8-13) TO PROVIDE THERMAL PATHWAYS TO YOUR PRINTED CIRCUIT BOARD'S GROUND PLANE.

DETAIL A

OUTLINE DIMENSIONS

The ADSP-21160M comes in a 27mm × 27mm, 400-ball Metric PBGA package with 20 rows of balls.

400-BALL METRIC PBGA (B-400)



- 2. CENTER FIGURES ARE NOMINAL DIMENSIONS. 3. THE ACTUAL POSITION OF THE BALL GRID IS WITHIN 0.30 OF ITS IDEAL POSITION RELATIVE TO THE PACKAGE EDGES.
- 4. THE ACTUAL POSITION OF EACH BALL IS WITHIN 0.10 OF ITS IDEAL POSITION RELATIVE TO THE BALL GRID.

ORDERING GUIDE

Part Number ^{1, 2}	Case Temperature Range	Instruction Rate	On-Chip SRAM	Operating Voltage
ADSP-21160MKB-80	0°C to 85°C	80 MHz	4 Mbit	2.5 INT/3.3 EXT V

¹B = Plastic Ball Grid Array (PBGA) package. ²See ADSP-21160N data sheet for ordering information for higher-performance derivative.

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Datasheets for electronics components.